SONY

Diagonal 6.15 mm (Type 1/2.9) CMOS Image Sensor with Square Pixel for Color Cameras

TENTATIVE

IMX326LQC-C

STARVIS

Description

The IMX326LQC-C is a diagonal 6.15 mm (Type 1/2.9) CMOS image sensor with a color square pixel array and approximately 6.82 M effective pixels. 12-bit digital output makes it possible to output the signals of approximately 6.82 M effective pixels with high definition for shooting still pictures.

It also operates with three power supply voltages: analog 2.8 V, digital 1.2 V, and 1.8 V for I/O interface and achieves low power consumption.

Realizing high-sensitivity, low dark current, this sensor also has an electronic shutter function with variable storage time.

(Application: Surveillance, FA cameras, Industrial cameras)

Features

- ◆ CMOS active pixel type pixels
- ◆ Input clock frequency 6 to 27 MHz (CSI-2), 12 / 24 / 36 / 72 MHz (Sub-LVDS)
- ♦ Both MIPI Specifications (CSI-2 high-speed serial interface) and Sub-LVDS supported
- ◆ All-pixel scan mode 12-bit, 10-bit 5M, 4M cropping mode
- ◆ High-sensitivity, low dark current, no smear, excellent anti-blooming characteristics
- ◆ Variable-speed shutter function (minimum unit: 1 horizontal period)
- ◆ Low power consumption
- ◆ High dynamic range (HDR) function: Digital overlap HDR
- ◆ H driver, V driver and serial communication circuit on chip
- ◆CDS/PGA on chip: Gain +27 dB (step pitch 0.1 dB)
- ◆ 10-bit/12-bit A/D conversion on chip
- ◆R, G, B primary color mosaic filters on chip
- All-pixel simultaneous reset supported
- ◆92-pin high-precision ceramic package



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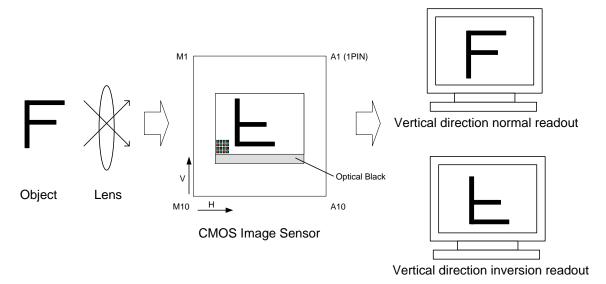
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Device Structure

- ◆ CMOS image sensor
- ◆ Image size Diagonal 6.15 mm (Type 1/2.9)
- ◆ Total number of pixels 3096 (H) x 2218 (V) approx. 6.87 M pixels
- ◆ Number of effective pixels
 3096 (H) × 2202 (V) approx. 6.82 M pixels
 2616 (H) × 1986 (V) approx. 5.20 M pixels
 3096 (H) × 1770 (V) approx. 5.48 M pixels
 2184 (H) × 2202 (V) approx. 4.81 M pixels
- ◆ Number of active pixels 3096 (H) × 2196 (V) approx. 6.80 M pixels diagonal 6.15 mm 2616 (H) × 1980 (V) approx. 5.18 M pixels diagonal 5.31 mm 3096 (H) × 1764 (V) approx. 5.46 M pixels diagonal 5.77 mm 2184 (H) × 2196 (V) approx. 4.80 M pixels diagonal 5.02 mm
- Number of recommended recording pixels 3072 (H) x 2160 (V) 6.64 M pixels aspect ratio 3:2 2592 (H) x 1944 (V) 5.04 M pixels aspect ratio 4:3 3072 (H) x 1728 (V) 5.31 M pixels aspect ratio 16:9 2160 (H) x 2160 (V) 4.67 M pixels aspect ratio 1:1
- ◆ Unit cell size 1.62 µm (H) × 1.62 µm (V)
- ◆ Optical black
 Horizontal (H) direction: Front 0 pixel, rear 0 pixel
 Vertical (V) direction: Front 16 pixels, rear 0 pixel
- Substrate material Silicon

Optical Black Array and Readout Scan Direction

(Top View)



Note) Arrows in the figure indicate scanning direction during normal readout in the vertical direction.

Optical Black Array and Readout Scan Direction

Absolute Maximum Ratings

Item	Symbol	Ratings	Unit	
Supply voltage (Analog)	V_{ADD}^{*1}	-0.3 to +3.3	V	
Supply voltage (Digital 1)	V _{DDD1} *2	-0.5 to +2.0	V	
Supply voltage (Digital 2)	V _{DDD2} *3	-0.5 to +3.3	V	
Input voltage (Digital)	Vı	V_1 = -0.3 to $V_{DDD2} + 0.3$		
Output voltage (Digital)	Vo	-0.3 to $V_{DDD2} + 0.3$	V	
Guaranteed operating temperature	T _{OPR}	-30 to +75	°C	
Storage guarantee temperature	T _{STG}	-30 to +80	°C	
Performance guarantee temperature	T _{SPEC}	-10 to +60	°C	

Recommended Operating Conditions

Item	Symbol	Rating	Unit
Supply voltage (Analog)	V_{ADD}^{*1}	2.8 ± 0.1	V
Supply voltage (Digital 1)	V _{DDD1} *2	1.2 ± 0.1	V
Supply voltage (Digital 2)	V_{DDD2}^{*3}	1.8 ± 0.1	V
Input voltage (Digital)	Vı	-0.1 to $V_{DDD2} + 0.1$	V

 $^{^{11}}$ V_{ADD}: V_{DD}SUB, V_{DD}HCM, V_{DD}HPX, V_{DD}HDA, V_{DD}HCP (2.8 V power supply)

V_{DDD1}: V_{DD}LCN, V_{DD}LSC1 to 2, V_{DD}LPA, V_{DD}LPL1, V_{DD}LPL2 to 3, V_{DD}LIF (1.2 V power supply)

^{*3} V_{DDD2}: V_{DD}MIO, V_{DD}MIF (1.8 V power supply)

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Optical Center

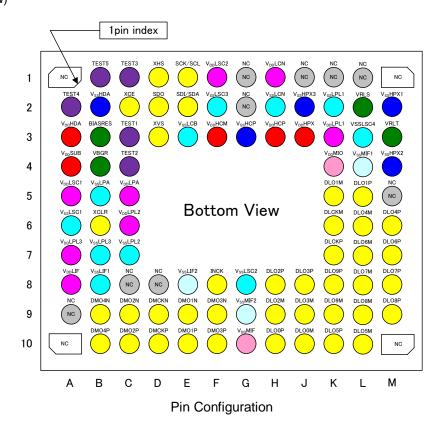
(Top View) **TBD**

* See page 107 "Package Outline" for details

Optical Center

Pin Configuration

(Bottom View)



Pin Description

When using CSI-2

Pin No.	Symbol	I/O	A/D	Pin description (CSI-2)	State in Standby mode	Remarks
A2	TEST4	0	А	Test		Leave open. (No connection)
А3	$V_{DD}HDA$	Power	Α	Analog power supply (2.8 V)	_	,
A4	V _{DD} SUB	Power	Α	Analog power supply (2.8 V)	_	
A5	V _{DD} LSC1	Power	D	Digital power supply (1.2 V)	_	
A6	V _{SS} LSC1	GND	D	Digital GND (1.2 V)	_	
A7	V _{DD} LPL3	Power	D	Digital power supply (1.2 V)	_	
A8	$V_{DD}LIF$	Power	D	Digital power supply (1.2 V)	_	
B1	TEST5	0	А	Test		Leave open. (No connection)
B2	V _{SS} HDA	GND	Α	Analog GND (2.8 V)	_	,
В3	BIASRES	0	А	Resister connection		Leave open. (No connection)
B4	VBGR	0	А	Capacitor connection		Leave open. (No connection)
B5	V _{SS} LPA	GND	D	Digital GND (1.2 V)	_	·
B6	XCLR	I	D	Reset pulse input	_	
B7	V _{SS} LPL3	GND	D	Digital GND (1.2 V)	_	
B8	V _{SS} LIF1	GND	D	Digital GND (1.2 V)	_	
В9	DMO4N	0	D	Digital MIPI output	Low Level	Data Lane 4 connection
B10	DMO4P	0	D	Digital MIPI output	Low Level	Data Lane 4 connection
C1	TEST3	0	D	Test		Leave open. (No connection)
C2	XCE	I	D	Connect to 1.8 V power supply	_	
С3	TEST1	1	D	Test		Leave open. (No connection)
C4	TEST2	1	D	Test		Leave open. (No connection)
C5	V _{DD} LPA	Power	D	Digital power supply (1.2 V)	_	
C6	V _{DD} LPL2	Power	D	Digital power supply (1.2 V)	_	
C7	V _{SS} LPL2	GND	D	Digital GND (1.2 V)	_	
C9	DMO2N	0	D	Digital MIPI output	Low Level	Data Lane 2 connection
C10	DMO2P	0	D	Digital MIPI output	Low Level	Data Lane 2 connection
D1	XHS	0	D	Horizontal sync signal output	_	If unused XHS, leave open.
D2	SDO	0	D	Test output	Low Level	Leave open. (No connection)
D3	XVS	0	D	Vertical sync signal output	_	If unused XVS, leave open.
D9	DMCKN	0	D	Digital MIPI output	Low Level	Clock Lane connection.
D10	DMCKP	0	D	Digital MIPI output	Low Level	Clock Lane connection.
E1	SCL	ı	D	I ² C communication clock input	_	COTITIONION.
		,		I ² C communication data		
E2	SDA	I/O	D	input/output	_	

D:		1			1 0, , ;	T
Pin	Symbol	I/O	A/D	Pin description	State in	Remarks
No.	,			(CSI-2)	Standby mode	
E3	V _{SS} LCB	GND	D	Digital GND (1.2 V)	_	
E8	V _{SS} LIF2	GND	D	Digital GND (1.2 V)		
E9	DMO1N	0	D	Digital MIPI output	Low Level	Data Lane 1 connection
E10	DMO1P	0	D	Digital MIPI output	Low Level	Data Lane 1 connection
F1	V _{DD} LSC2	Power	D	Digital power supply (1.2 V)	_	
F2	V _{SS} LSC3	GND	D	Digital GND (1.2 V)	_	
F3	V _{DD} HCM	Power	Α	Analog power supply (2.8 V)	_	
F8	INCK	ı	D	Input clock	_	
F9	DMO3N	0	D	Digital MIPI output	Low Level	Data Lane 3 connection
F10	DMO3P	0	D	Digital MIPI output	Low Level	Data Lane 3 connection
G3	V _{SS} HCP	GND	Α	Analog GND (2.8 V)	_	
G8	V _{SS} LSC2	GND	D	Digital GND (1.2 V)	_	
G9	V _{SS} MIF2	GND	D	Digital GND (1.8 V)	_	
G10	V _{DD} MIF	Power	D	Digital power supply (1.8 V)	_	
H1	V _{DD} LCN	Power	D	Digital power supply (1.2 V)	_	
H2	V _{SS} LCN	GND	D	Digital GND (1.2 V)	<u> </u>	
H3	V _{DD} HCP	Power	A	Analog power supply (2.8 V)		
110	V DDI IOI	1 OWCI	- / \	/ Trialog power supply (2.0 v)		Leave open.
H8	DLO2P	0	D	(Pin for Sub-LVDS)		(No connection)
H9	DLO2M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
H10	DLO0P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
J2	V _{SS} HPX3	GND	Α	Analog GND (2.8 V)		
J3	$V_{DD}HPX$	Power	Α	Analog power supply (2.8 V)	_	
J8	DLO3P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
J9	DLO3M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
J10	DLO0M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
K2	V _{SS} LPL1	GND	D	Digital GND (1.2 V)	_	(
K3	V _{DD} LPL1	Power		Digital power supply (1.2 V)	_	
K4	V _{DD} MIO	Power		Digital power supply (1.8 V)	_	
K5	DLO1M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
K6	DLCKM	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
K7	DLCKP	0	D	(Pin for Sub-LVDS)		Leave open.
K8	DLO9P	0	D	(Pin for Sub-LVDS)		(No connection) Leave open.
K9	DLO9M	0		(Pin for Sub-LVDS)		(No connection) Leave open.
				,		(No connection) Leave open.
K10	DLO5P	0	D	(Pin for Sub-LVDS)		(No connection)

Pin No.	Symbol	I/O	A/D	Pin description (CSI-2)	State in Standby mode	Remarks
L2	VRLS	0	Α	Capacitor connection	Pull-down	
L3	V _{SS} LSC4	GND	D	Digital GND (1.2 V)	_	
L4	V _{SS} MIF1	GND	D	Digital GND (1.8 V)	_	
L5	DLO1P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
L6	DLO4M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
L7	DLO6M	0	D	(Pin for Sub-LVDS)		
L8	DLO7M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
L9	DLO8M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
L10	DLO5M	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
M2	V _{SS} HPX1	GND	Α	Analog GND (2.8 V)	_	
М3	VRLT	0	Α	Capacitor connection	Pull-down	
M4	V _{SS} HPX2	GND	Α	Analog GND (2.8 V)	_	
M6	DLO4P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
M7	DLO6P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
M8	DLO7P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)
M9	DLO8P	0	D	(Pin for Sub-LVDS)		Leave open. (No connection)

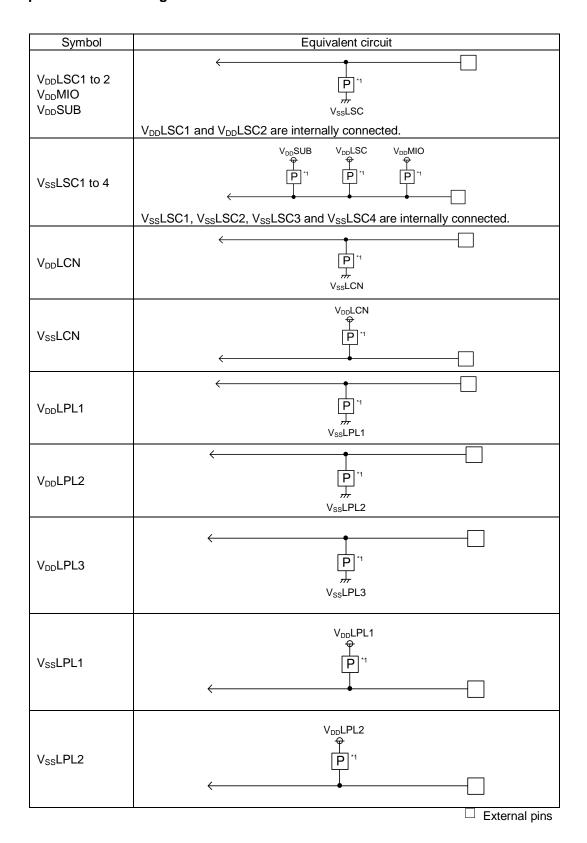
When using Sub-LVDS

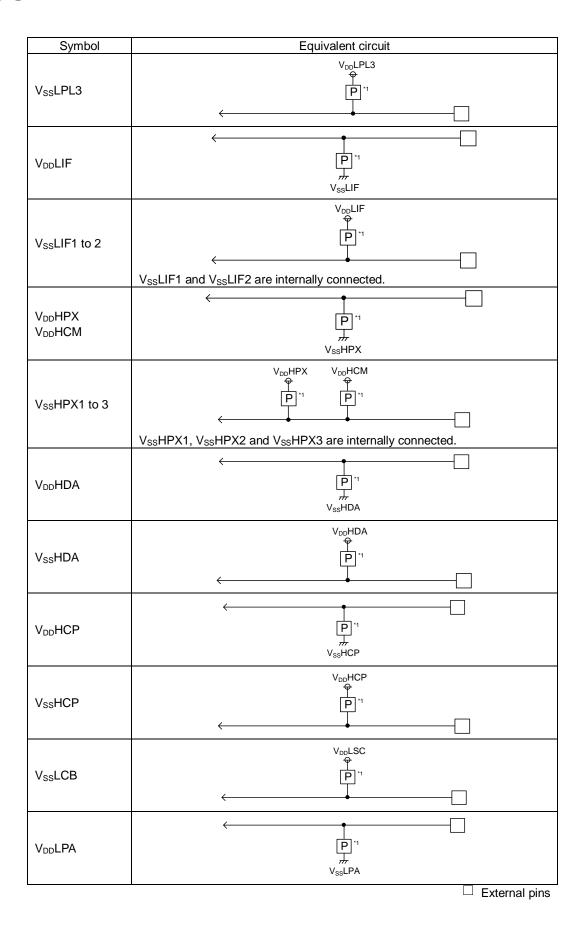
Pin No.	Symbol	I/O	A/D	Pin description (Sub-LVDS)	State in Standby mode	Remarks
A2	TEST4	0	Α	Test	Clairiasy meas	Leave open. (No connection)
A3	V _{DD} HDA	Power	A	Analog power supply (2.8 V)	_	(140 COTITIECTION)
A4	V _{DD} SUB	Power	A	Analog power supply (2.8 V)		
A5	V _{DD} LSC1	Power		Digital power supply (1.2 V)		
A6	V _{SS} LSC1	GND	D	Digital GND (1.2 V)		
A7	V _{SS} LSC1	Power	D	Digital power supply (1.2 V)		
A8	V _{DD} LIF	Power	D	Digital power supply (1.2 V)		
70	VUULII	1 OWEI	<u> </u>	Digital power supply (1.2 v)		Leave open.
B1	TEST5	0	Α	Test		(No connection)
B2	V _{SS} HDA	GND	Α	Analog GND (2.8 V)	_	
В3	BIASRES	0	Α	Resister connection		Leave open. (No connection)
B4	VBGR	0	Α	Capacitor connection		Leave open. (No connection)
B5	V _{SS} LPA	GND	D	Digital GND (1.2 V)	_	(**************************************
B6	XCLR	1		Reset pulse input	_	
B7	V _{SS} LPL3	GND	D	Digital GND (1.2 V)	_	
B8	V _{SS} LIF1	GND	D	Digital GND (1.2 V)	_	
				` ,		Leave open.
B9	DMO4N	0	D	(Pin for CSI-2)		(No connection)
B10	DMO4P	0	D	(Pin for CSI-2)		Leave open.
						(No connection) Leave open.
C1	TEST3	0	D	Test		(No connection)
C2	XCE	I	D	Serial communication enable input	_	
С3	TEST1	I	D	Test		Leave open. (No connection)
C4	TEST2	I	D	Test		Leave open. (No connection)
C5	V _{DD} LPA	Power	D	Digital power supply (1.2 V)	_	(NO CONNECTION)
C6	V _{DD} LPL2	Power	D	Digital power supply (1.2 V)	_	
C7	V _{SS} LPL2	GND	D	Digital GND (1.2 V)	_	
						Leave open.
C9	DMO2N	0	D	(Pin for CSI-2)		(No connection)
C10	DMO2P	0	D	(Pin for CSI-2)		Leave open. (No connection)
D1	XHS	I	D	Horizontal sync signal input	_	,
D2	SDO	0	D	Test output	Low Level	Leave open. (No connection)
D3	XVS	I	D	Vertical sync signal input	_	(1.10 0011110011011)
D9	DMCKN	0	D	(Pin for CSI-2)		Leave open. (No connection)
D10	DMCKP	0	D	(Pin for CSI-2)		Leave open. (No connection)
E1	SCK	1	D	Serial communication clock input	_	(140 COHHECTION)
E2	SDI	ı				
E2		GND	D	Serial communication data input	_	
	V _{SS} LCB		D	Digital GND (1.2 V)	_	
E8	V _{SS} LIF2	GND	D	Digital GND (1.2 V)	_	

					T	
Pin	Symbol	I/O	A/D	Pin description	State in	Remarks
No.	Cyllibol	1/0	7,0	(Sub-LVDS)	Standby mode	Remarks
	DMO4N)	_	(Din for CCL 2)		Leave open.
E9	DMO1N	0	D	(Pin for CSI-2)		(No connection)
		_	_			Leave open.
E10	DMO1P	0	D	(Pin for CSI-2)		(No connection)
F1	V _{DD} LSC2	Power	D	Digital power supply (1.2 V)		(110 0011110011011)
F2			D		_	
	V _{SS} LSC3	GND		Digital GND (1.2 V)	_	
F3	V _{DD} HCM	Power	A	Analog power supply (2.8 V)	_	
F8	INCK		D	Input clock	_	
F9	DMO3N	0	D	(Pin for CSI-2)		Leave open.
13	DIVIOSIN		D	(1 111 101 C31-2)		(No connection)
E40	DMOOD		,	(P: (Leave open.
F10	DMO3P	0	D	(Pin for CSI-2)		(No connection)
G3	V _{SS} HCP	GND	Α	Analog GND (2.8 V)	_	7
G8	V _{SS} LSC2	GND	D	Digital GND (1.2 V)	_	
G9	V _{SS} MIF2	GND	D	Digital GND (1.8 V)		
				ŭ ,		
G10	V _{DD} MIF	Power	D	Digital power supply (1.8 V)	_	
H1	V _{DD} LCN	Power	D	Digital Power supply (1.2 V)	_	
H2	$V_{SS}LCN$	GND	D	Digital GND (1.2 V)	_	
H3	$V_{DD}HCP$	Power	Α	Analog power supply (2.8 V)	_	
		_	_			Digital LVDS
H8	DLO2P	0	D	Digital Sub-LVDS output	Hi-Z	output
						Digital LVDS
H9	DLO2M	0	D	Digital Sub-LVDS output	Hi-Z	•
						output
H10	DLO0P	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS
						output
J2	V _{SS} HPX3	GND	Α	Analog GND (2.8 V)	_	
J3	$V_{DD}HPX$	Power	Α	Analog power supply (2.8 V)	_	
10	DI COD)	_	Digital Cub IV/DC gutgut	11: 7	Digital LVDS
J8	DLO3P	0	D	Digital Sub-LVDS output	Hi-Z	output
		_	_			Digital LVDS
J9	DLO3M	0	D	Digital Sub-LVDS output	Hi-Z	output
						Digital LVDS
J10	DLO0M	0	D	Digital Sub-LVDS output	Hi-Z	•
1/0	V 1 DI 4	OND		Divided OND (4.0.)		output
K2	V _{SS} LPL1	GND	<u>D</u>	Digital GND (1.2 V)	_	
K3	V _{DD} LPL1	Power	D	Digital power supply (1.2 V)	_	
K4	$V_{DD}MIO$	Power	D	Digital power supply (1.8 V)	-	
VE	DI O1M		D	Digital Sub IV/DS autout	Hi-Z	Digital LVDS
K5	DLO1M	0	D	Digital Sub-LVDS output	HI-Z	output
		_				Digital LVDS
K6	DLCKM	0	D	Digital Sub-LVDS output	Hi-Z	output
						Digital LVDS
K7	DLCKP	0	D	Digital Sub-LVDS output	Hi-Z	•
						output
K8	DLO9P	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS
			-	2	. =	output
K9	DI OOM	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS
1/3	DLO9M			Digital Sub-LvDS Output	1 11-2	output
1//10	DI CED		_	Divided O L DVDC	11: 7	Digital LVDS
K10	DLO5P	0	D	Digital Sub-LVDS output	Hi-Z	output
L2	VRLS	0	Α	Capacitor connection	Pull-down	Т
L3	V _{SS} LSC4	GND	D	Digital GND (1.2 V)	i dii dowii	
				-	_	
L4	V _{SS} MIF1	GND	D	Digital GND (1.8 V)	_	

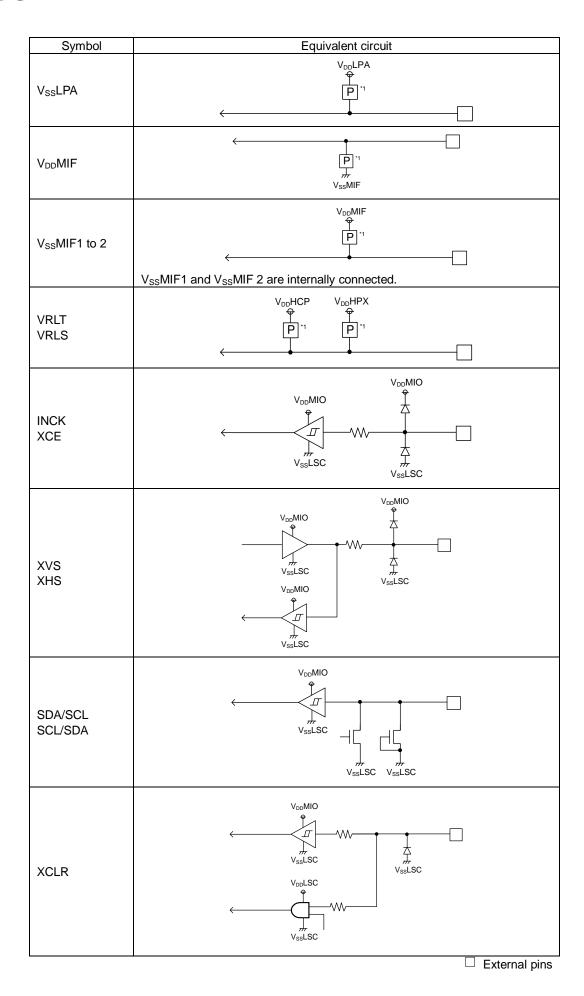
Pin No.	Symbol	I/O	A/D	Pin description (Sub-LVDS)	State in Standby mode	Remarks
L5	DLO1P	0	D	Digital Sub-LVDS output	Digital Sub-LVDS output Hi-Z	
L6	DLO4M	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
L7	DLO6M	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
L8	DLO7M	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
L9	DLO8M	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
L10	DLO5M	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
M2	V _{SS} HPX1	GND	Α	Analog GND (2.8 V)	_	
M3	VRLT	0	Α	Capacitor connection	Pull-down	
M4	V _{SS} HPX2	GND	Α	Analog GND (2.8 V)	_	
M6	DLO4P	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
M7	DLO6P	0	D	Digital Sub-LVDS output	Hi-Z	Digital LVDS output
M8	DLO7P	0	D	Digital Sub-LVDS output	Digital Sub-LVDS output Hi-Z	
M9	DLO8P	0	D	Digital Sub-LVDS output Hi-/		Digital LVDS output

I/O Equivalent Circuit Diagram

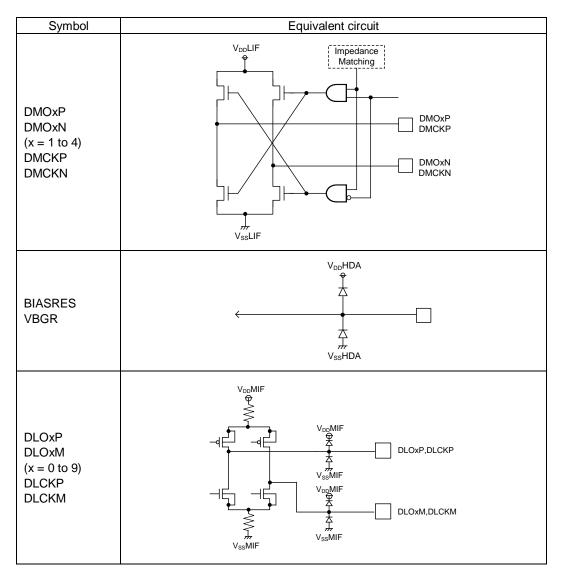




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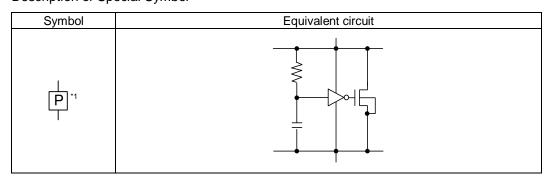


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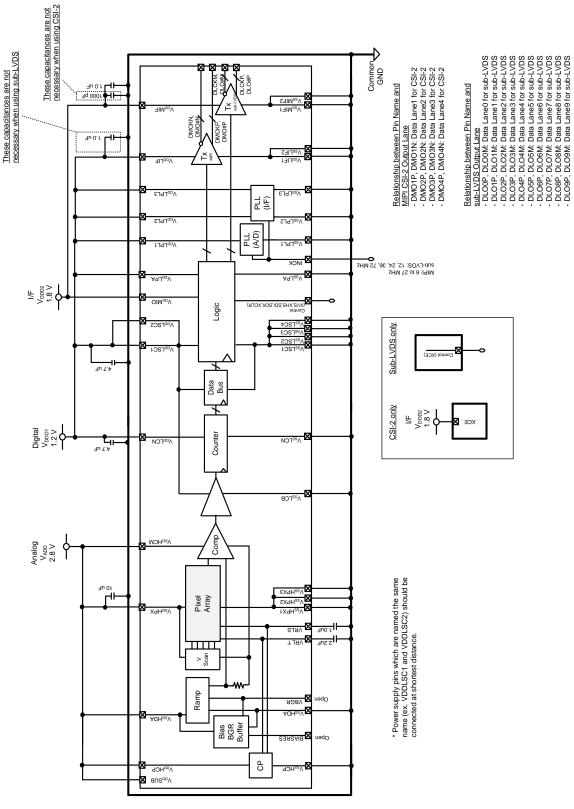


 $\ \square$ External pins

Description of Special Symbol



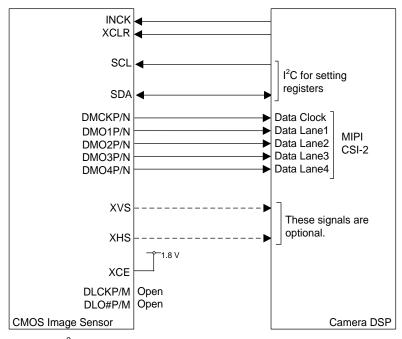
Peripheral Circuit



Peripheral Circuit

System Outline

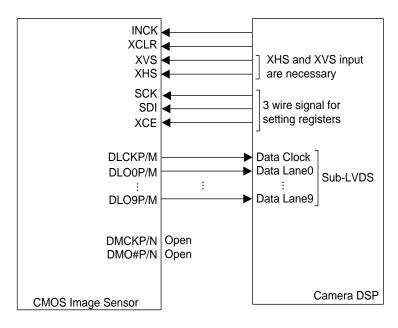
When using CSI-2



- * I²C communication only can be used when using MIPI CSI-2
- * Sensor Master operation only

System Outline When Using CSI-2

When using Sub-LVDS



- * 3-wire serial communication only can be used when using Sub-LVDS
- * Sensor Slave operation only
- * INCK and XHS should be synchronized.

System Outline When Using Sub-LVDS

Electrical Characteristics when using CSI-2

1. DC Characteristics (CSI-2)

Current Consumption and Gain Variable Range (CSI-2)

(V_{ADD} = 2.9 V, V_{DDD1} = 1.3 V, V_{DDD2} = 1.9 V, Tj = 60 °C, Reference Gain (0 dB) All pixel scan mode (MODE0), 30.00 frame/s)

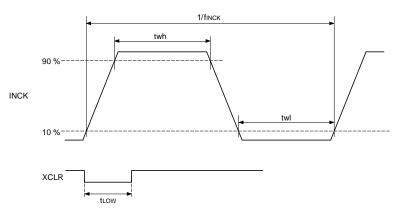
Item	Symbol	Min.	Тур.	Max	Unit	Remarks
Current consumption (Analog)	I _{ADD}	_	1	TBD	mA	
Current consumption (Digital 1)	I _{DDD1}	_	1	TBD	mA	
Current consumption (Digital 2)	I_{DDD2}	_	ı	TBD	mA	
Standby current (Analog)	I _{ADDSTB}	_	1	TBD	μΑ	In the dark
Standby current (Digital 1)	I _{DDD1STB}	_	ı	TBD	mA	In the dark
Standby current (Digital 2)	I _{DDD2STB}	_		TBD	μΑ	In the dark
PGA gain variable range	PGAG	0	_	27	dB	

Supply Voltage and I/O Voltage (CSI-2)

It	em	Pins	Symbol	Min.	Тур.	Max.	Unit
	Analog	V _{DD} SUB, V _{DD} HCM, V _{DD} HPX, V _{DD} HDA, V _{DD} HCP	V _{ADD}	2.70	2.80	2.90	V
Supply voltage	Digital 1	V _{DD} LCN, V _{DD} LSC1 to 2, V _{DD} LPL1, V _{DD} LPA, V _{DD} LPL2 to 3, V _{DD} LIF	V _{DDD1}	1.10	1.20	1.30	V
	Digital 2	$V_{DD}MIO$, $V_{DD}MIF$	V_{DDD2}	1.70	1.80	1.90	V
		SDA,	V_{IH1}	$0.7 \times V_{DDD2}$	_	1.9	V
Digital in	put	SCL	V_{IL1}	-0.3	_	$0.3 \times V_{DDD2}$	V
voltage		XCLR,	V_{IH2}	$0.7 \times V_{DDD2}$		$V_{DDD2} + 0.3$	V
		INCK	V_{IL2}	-0.3	_	$0.3 \times V_{DDD2}$	V
Digital ou voltage	ıtput	XHS, XVS	V _{HVOUT}	_	V _{DDD2}	_	V

2. AC Characteristics (CSI-2)

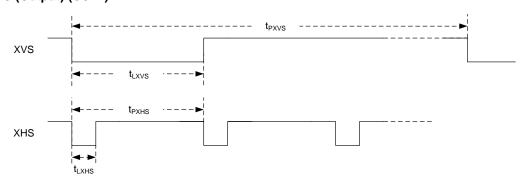
INCK, XCLR (CSI-2)



INCK, XCLR (CSI-2)

Item	Symbol	Min.	Тур.	Max.	Unit
INCK clock frequency	f _{INCK}	6	_	27	MHz
INCK Low level pulse width	twl	5	_	_	ns
INCK High level pulse width	twh	5	_	_	ns
Clock duty	_	40	50	60	%
XCLR Low level pulse width	t _{LOW}	100	_	_	ns

XHS, XVS (Output) (CSI-2)



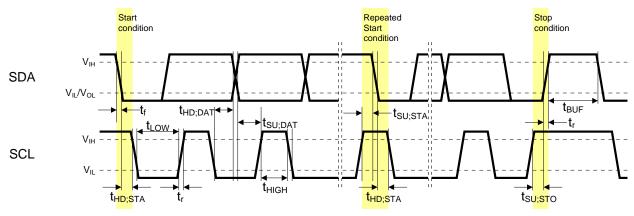
XHS, XVS Output (CSI-2)

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
XHS Low level pulse width	t _{LXHS}		222		ns	16 clk@72MHz
XHS pulse period	t _{PXHS}		HMAX ^{*1}		clk@72MHz	
XVS Low level pulse width	t _{LXVS}		t _{PXHS}		clk@72MHz	
XVS pulse period	t _{PXVS}		HMAX ^{*1} × VMAX ^{*2}		clk@72MHz	

^{*1} The value set as HMAX (address 30F6h, bit [7:0] and address 30F7h, bit [7:0])

The value set as VMAX (address 30F8h, bit [7:0], address 30F9h, bit [7:0] and address 30FAh, bit [3:0]).

I²C Communication (CSI-2)



I²C Communication (CSI-2)

I²C Specification

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
Low level input voltage	V _{IL}	-0.3	_	0.3 × V _{DDD2}	V	
High level input voltage	V _{IH}	$0.7 \times V_{DDD2}$	_	1.9	V	
Low level output voltage	V _{OL}	0	_	$0.2 \times V_{DDD2}$	V	V _{DDD2} < 2 V, Sink 3 mA
Output fall time	tof	_		250	ns	Load 10 pF to 400 pF, $0.7 \times V_{DDD2}$ to $0.3 \times V_{DDD2}$
Input current (SCL, SDA, XCLR, INCK)	li	-10	_	10	μΑ	$0.1 \times V_{DDD2}$ to $0.9 \times V_{DDD2}$
Input capacitance of SCL / SDA	Ci	_	_	10	pF	

I²C AC Characteristics

Item	Symbol	Min.	Тур.	Max.	Unit
SCL clock frequency	f _{SCL}	0	_	400	kHz
Hold time (Start Condition)	t _{HD;STA}	0.6	_	_	μs
Low period of the SCL clock	t _{LOW}	1.3	_	_	μs
High period of the SCL clock	t _{HIGH}	0.6	_	_	μs
Set-up time (Repeated Start Condition)	t _{SU;STA}	0.6	_	_	μs
Data hold time	t _{HD;DAT}	0	_	0.9	μs
Data set-up time	t _{SU;DAT}	100	_	_	ns
Rise time of both SDA and SCL signals	t _r	_	_	300	ns
Fall time of both SDA and SCL signals	t _f	_	_	300	ns
Set-up time (Stop Condition)	t _{SU;STO}	0.6	_	_	μs
Bus free time between a STOP and START Condition	t _{BUF}	1.3		_	μs

DMCKP / DMCKN, DMO (CSI-2)

Detailed explanation of CSI-2 interface is in following two documents, "MIPI Alliance Standard for Camera Serial Interface2(CSI-2) Version 1.1" and "MIPI Alliance Specification for D-PHY Version 1.1".

Four data output Lanes are applied from MIPI Alliance Standard for Camera Serial Interface2(CSI-2) Version 1.1.

Electrical Characteristics When Using Sub-LVDS

1. DC Characteristics (Sub-LVDS)

Current Consumption and Gain Variable Range (Sub-LVDS)

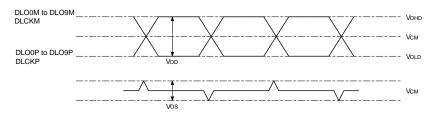
 $(V_{ADD} = 2.9 \text{ V}, V_{DDD1} = 1.3 \text{ V}, V_{DDD2} = 1.9 \text{ V}, Tj = 60 ^{\circ}\text{C}, Reference Gain (0 dB)}$ All pixel scan mode (MODE0), 30.00 frame/s)

Item	Symbol	Min.	Тур.	Max	Unit	Remarks
Current consumption (Analog)	I _{ADD}	_	1	TBD	mA	
Current consumption (Digital 1)	I _{DDD1}	_	1	TBD	mA	
Current consumption (Digital 2)	I_{DDD2}	_	_	TBD	mA	
Standby current (Analog)	I _{ADDSTB}	_	_	TBD	μA	In the dark
Standby current (Digital 1)	I _{DDD1STB}	_	ı	TBD	mA	In the dark
Standby current (Digital 2)	I _{DDD2STB}	_		TBD	μA	In the dark
PGA gain variable range	PGAG	0	_	27	dB	

Supply Voltage and I/O Voltage (Sub-LVDS)

Ite	em	Pins	Symbol	Min.	Тур.	Max.	Unit
	Analog	V _{DD} SUB, V _{DD} HCM, V _{DD} HPX, V _{DD} HDA, V _{DD} HCP	V_{ADD}	2.70	2.80	2.90	V
Supply voltage	Digital 1	V _{DD} LCN, V _{DD} LSC1 to 2, V _{DD} LPL1, V _{DD} LPA, V _{DD} LPL2 to 3, V _{DD} LIF	V_{DDD1}	1.10	1.20	1.30	V
	Digital 2	V _{DD} MIO, V _{DD} MIF	V_{DDD2}	1.70	1.80	1.90	V
Digital in	put	SCK, SDI, XCE, XHS, XVS,	V _{IH1}	$0.7 \times V_{DDD2}$	_	1.9	V
voltage		XCLR, INCK	V _{IL1}	-0.3	_	$0.3 \times V_{DDD2}$	V
Digital input leak cuurent		SCK, SDI, XCE, XHS, XVS, XCLR, INCK	I _{LI}	-10	_	10	uA

LVDS Output DC Characteristics (Sub-LVDS)



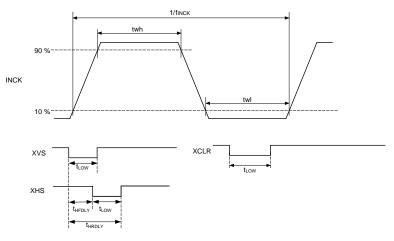
LVDS Output DC Characteristics (Sub-LVDS)

(Termination resistance: 100 Ω , LVDS current: 1.5 mA)

Item	Pins	Item	Symbol	Min.	Тур.	Max.	Unit
		Amplitude voltage	V_{OD}	100	150	200	mV
	BI GOD :	Common voltage	V_{CM}	V _{DDD2} /2 - 100	V _{DDD2} /2	V _{DDD2} /2 + 100	mV
Digital	DLO0P to DLO9P, DLO0M to	Common voltage fluctuation	Vos		20		mV
output	DLOOM to	High level output voltage	V_{OHD}	$V_{CM} + 50$	$V_{CM} + 75$	$V_{CM} + 100$	mV
voltage	DLO9M, DLCKP,	Low level output voltage	V_{OLD}	$V_{CM} - 100$	$V_{CM} - 75$	$V_{\text{CM}} - 50$	mV
	DLCKP, DLCKM	Difference between amplitude voltage channels	V_{ODP}		_	50	mV
		Difference between common voltage channels	V_{OSP}	_	_	50	mV

2. AC Characteristics (Sub-LVDS)

INCK, XCLR, XVS (input), XHS (input) (Sub-LVDS)

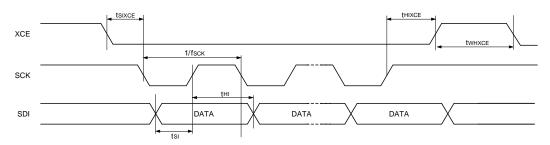


INCK, XCLR, XVS (input), XHS (input) (Sub-LVDS)

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
		71.0	72.0	73.0	MHz	INCK 72 MHz setting
INCK clock frequency	£	35.5	36.0	36.5	MHz	INCK 36 MHz setting
INCK Clock frequency	f _{INCK}	23.7	24.0	24.3	MHz	INCK 24 MHz setting
		11.9	12.0	12.1	MHz	INCK 12 MHz setting
INCK Low level pulse width	twl	5			ns	
INCK High level pulse width	twh	5			ns	
Clock duty	_	40	50	60	%	
XCLR Low level pulse width	t _{LOW}	100			ns	
XVS Low level pulse width	t _{LOW}	55		167	ns	
XHS Low level pulse width	t _{LOW}	55		167	ns	
XVS fall – XHS fall width	t _{HFDLY}	0			ns	
XVS fall – XHS rise width	t _{HRDLY}	55		167	ns	

Serial Communication (Sub-LVDS)

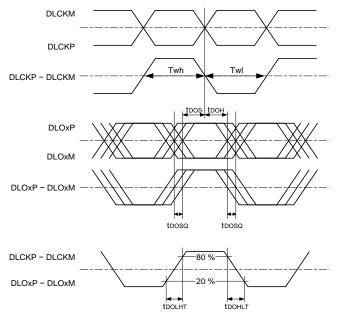
Serial Control Interface Timing



Serial Control Interface Timing (Sub-LVDS)

Item	Symbol	Min.	Тур.	Max.	Unit
SCK clock frequency	f _{SCK}	_	_	INCK/2	MHz
SDI input setup time	t _{SI}	7	_	_	ns
SDI input hold time	t _{HI}	7	_	_	ns
XCE input setup time	t _{SIXCE}	10	_	_	ns
XCE input hold time	t _{HIXCE}	10	_	_	ns
XCE High level pulse width	t _{WHXCE}	27			ns

Sub-LVDS Output (Sub-LVDS)



Note) "x" stands for the number of 0 to 9 and the time chart is specified for all output channels.

Sub-LVDS Output

(Termination resistance: 100 Ω, load capacitance: 0 pF)

Item	Symbol	Min.	Тур.	Max.	Unit	Remarks
DLO skew time (including jitter)	t _{DOSQ}			361	ps	Data rate 288 MHz DDR
DLO setup time	t _{DOS}	420	_	_	ps	Data rate 288 MHz DDR
DLO hold time	t _{DOH}	420	_	_	ps	Data rate 288 MHz DDR
DLO rise time	t _{DOLHT}	_	500	600	ps	Simulated value with load capacitance (4 pF)
DLO fall time	t _{DOHLT}	1	500	600	ps	Simulated value with load capacitance (4 pF)
DCK duty cycle	D _{DCDCK}	45	50	55	%	
DCK pulse width	Twh, Twl	1319	_	_	ps	Including period jitter

Spectral Sensitivity Characteristics (CSI-2 and Sub-LVDS)

(Excludes lens characteristics and light source characteristics)

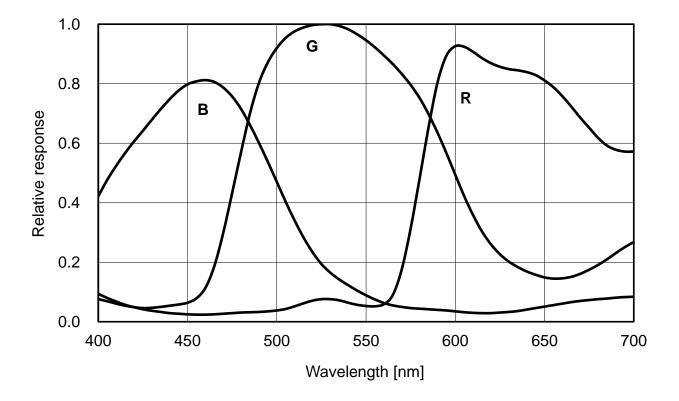


Image Sensor Characteristics (CSI-2 and Sub-LVDS)

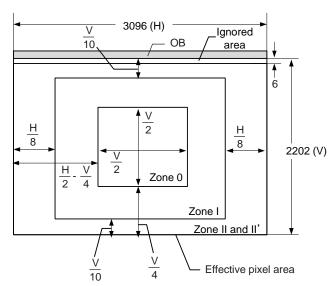
 $(V_{ADD} = 2.8 \text{ V}, V_{DDD1} = 1.2 \text{ V}, V_{DDD2} = 1.8 \text{ V}, Tj = 60 ^{\circ}\text{C}, 29.97 \text{ frame/s}, Reference Gain (0 dB))}$

Item		Symbol	Min.	Тур.	Max.	Unit	Measurement method	Remarks	
G sensitivity	SITIVITY I SA I		digit ^{*1} (mV)	1	1/30 s integration conversion value Zone 0				
Sensitivity	R	Rr	36	_	62	%	1	Zone 0	
ratio	В	Rb	35	_	55	%	1	Zone u	
Saturation signa	ıl	Vsat	3050 (630)	_	_	digit ^{*1} (mV)	2	Zone 0 to II'	
Dark signal		Vdt	0 (0)	1	0.49 (0.1)	digit ^{*1} (mV)	3	1/30 s integration conversion value Zone 0 to II'	
Dark signal shading		ΔVdt	0 (0)		0.68 (0.14)	digit ^{*1} (mV)	4	1/30 s integration conversion value Zone 0 to II'	

⁵ Shows digit when 12-bit output. 1 digit ≈ 0.2068 mV when 12-bit output (1 digit ≈ 0.8272 mV when 10-bit output).

1. Zone Definition of Image Sensor Characteristics

Zone definition of image sensor characteristics and reference position during dark signal measurement are shown below.



Zone Definition of Image Sensor Characteristics and Reference Position during Dark Signal Measurement

Zone Definition of Image Sensor Characteristics

Image Sensor Characteristics Measurement Method (CSI-2 and Sub-LVDS)

1. Measurement Conditions

- (1) In the following measurements, the device drive conditions are at the typical values of the bias conditions and clock voltage conditions.
- (2) In the following measurements, spot pixels are excluded and, unless otherwise specified, the optical black (OB) level is used as the reference for the signal output, which is taken as the value of the Gr/Gb channel signal output or the R/B channel signal output of the measurement system.

2. Color Coding of this Image Sensor and Readout

The primary color filters of this image sensor are arranged in the layout shown in the figure below. Gr and Gb represent the G signal on the same line as the R and B signals, respectively. The Gb signal and B signal lines and the R signal and Gr signal lines are output successively.

Gb	В	Gb	В	
R	Gr	R	Gr	
Gb	В	Gb	В	
R	Gr	R	Gr	

Color Coding Diagram

3. Definition of Standard Imaging Conditions

◆ Standard imaging condition I:

Use a pattern box (luminance: 706 cd/m², color temperature of 3200 K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0 mm) as an IR cut filter and image at F5.6. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.

Standard imaging condition II:

Image a light source (color temperature of 3200 K) with a uniformity of brightness within 2 % at all angles. Use a testing standard lens with CM500S (t = 1.0 mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

◆ Standard imaging condition III:

Image a light source (color temperature of 3200 K) with a uniformity of brightness within 2 % at all angles. Use a testing standard lens (exit pupil distance –27.1 mm) with CM500S (t = 1.0 mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. G sensitivity, Sensitivity ratio

Set the measurement condition to the standard imaging condition I. After setting the electronic shutter mode with a shutter speed of 1/75 s, measure the Gr, Gb, R and B signal outputs (VGr, VGb, VR and VB) at the center of the screen which is zone 0, and substitute the values into the following formula

VG = (VGr + VGb) / 2

 $Sg = VG \times 75/30 [digit]$

 $Rr = VR/VG \times 100$ [%]

 $Rb = VB/VG \times 100 [\%]$

2. Saturation signal

Set the measurement condition to the standard imaging condition II. Adjust the luminous intensity to 20 times the intensity with the average value of the G = (Gr + Gb)/2 signal output, 255 digit when 10-bit output (1020 digit when 12-bit output). Measure the minimum values of the Gr, Gb, R and B signals when shooting in rolling shutter mode.

SONY

3. Dark signal

Measure the average value (Vdt [digit]) of the signal output in zone 0 to zone II' in the light-obstructed state. Define the average value of the signal output accumulated in 1 frame period (t1v) as Vdt1V and the average value of the signal output accumulated in the shortest period (1H period: t1h) as Vdt1H, and then substitute the values into the following formula.

Vdt = (Vdt1V - Vdt1H) / (t1v - t1h) /30 [digit]

4. Dark signal shading

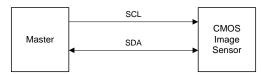
Following the item 4, measure the maximum value (Vdmax [digit]) and minimum value (Vdmin [digit]) of the dark signal output, and substitute the values into the following formula.

 $\Delta Vdt = Vdmax - Vdmin [digit]$

Setting Registers Using I²C Communication (When Using CSI-2)

Description of Setting Registers When Using I²C Communication

The serial data input order is MSB-first transfer. The table below shows the various data types and descriptions.



Pin connection of serial communication

SLAVE Address

MSB							LSB
0	0	1	1	0	1	0	R / W ^{*1}

^{*1} R/W is data direction bit

R/W

R / W bit	Data direction
0	Write (Master → Sensor)
1	Read (Sensor → Master)

Pin Connection of Serial Communication Operation Specifications When Using I²C Communication

The pin connection of serial communication method conforms to the Camera Control Instance (CCI). CCI is an I^2C fast-mode compatible interface, and the data transfer protocol is I^2C standard.

This pin connection of serial communication circuit can be used to access the control-registers and status-registers of the sensor.

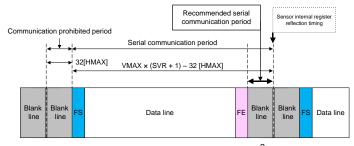
I²C pin description

Symbol	Pin No.	Remarks	
SCL	E1	Serial clock input	
SDA	E2	Serial data communication	

Register Communication Timing When Using I²C Communication

In I^2C communication system, register setting can be performed during the period when communication is from the following figure "VMAX × (SVR + 1) – 32[HMAX]".

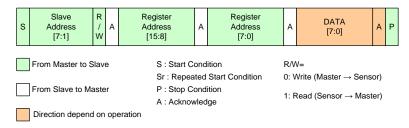
Perform I²C communication within "FS of next frame – 32[HMAX]" period (recommended serial communication period) after FE period end to prevent noise. However, for non-picture frames in which noise is ignored (immediately after power-on or immediately after switching the drive mode, etc.), then register communication can be performed other than during the recommended serial communication period of those frames.



Register Communication Timing When Using I²C Communication

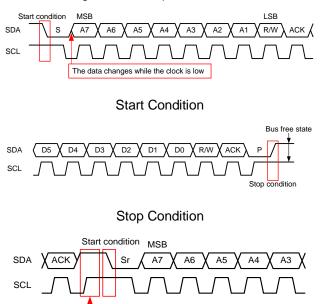
I²C Communication Protocol

I²C serial communication supports a 16-bit register address and 8-bit data message type.



I²C Communication Protocol

Data is transferred serially, MSB first in 8-bit units. After each data byte is transferred, A (Acknowledge) is transferred. Data is transferred at the clock cycle of SCL. SDA can change only while SCL is Low, so the SDA value must be held while SCL is High. The Start condition is defined by SDA changing from High to Low while SCL is High. When the Stop condition is not generated in the previous communication phase and Start condition for the next communication is generated, that Start condition is recognized as a Repeated Start condition.



Repeated Start Condition

The stop condition is not generated.

After transfer of each data byte, the Master or the sensor transmits an Acknowledge and release (does not drive) SDA.



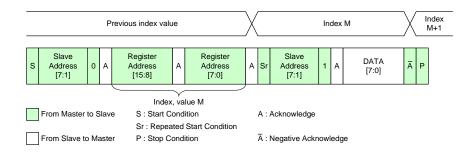
Acknowledge

Register Write and Read

This sensor supports to four read operations and two write operations. In addition, INCK signal must be driven during the l²C serial communication period.

Single Read from Random Location

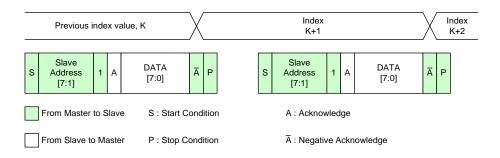
The sensor has an index function that indicates which address it is focusing on. In reading the data at an optional single address, the Master must set the index value to the address to be read. For this purpose it performs dummy write operation up to the register address. The upper level of the figure below shows the sensor internal index value, and the lower level of the figure shows the SDA I/O data flow. The Master sets the sensor index value to M by designating the sensor slave address with a write request, then designating the address (M). Then, the Master generates the start condition. The Start Condition is generated without generating the Stop Condition, so it becomes the Repeated Start Condition. Next, when the Master sends the slave address with a read request, the sensor outputs an Acknowledge immediately followed by the index address data on SDA. After the Master receives the data, it generates a Negative Acknowledge and the Stop Condition to end the communication



Single Read from Random Location

Single Read from Current Location

After the slave address is transmitted by a write request, that address is designated by the next communication and the index holds that value. In addition, when data read/write is performed, the index is incremented by the subsequent Acknowledge/Negative Acknowledge timing. When the index value is known to indicate the address to be read, sending the slave address with a read request allows the data to be read immediately after Acknowledge. After receiving the data, the Master generates a Negative Acknowledge and the Stop Condition to end the communication, but the index value is incremented, so the data at the next address can be read by sending the slave address with a read request.

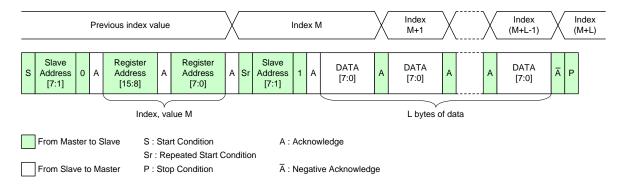


Single Read from Current Location



Sequential Read Starting from Random Location

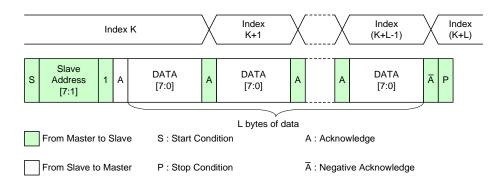
In reading data sequentially, which is starting from an optional address, the Master must set the index value to the start of the addresses to be read. For this purpose, dummy write operation includes the register address setting. The Master sets the sensor index value to M by designating the sensor slave address with a read request, then designating the address (M). Then, the Master generates the Repeated Start Condition. Next, when the Master sends the slave address with a read request, the sensor outputs an Acknowledge followed immediately by the index address data on SDA. When the Master outputs an Acknowledge after it receives the data, the index value inside the sensor is incremented and the data at the next address is output on SDA. This allows the Master to read data sequentially. After reading the necessary data, the Master generates a Negative Acknowledge and the Stop Condition to end the communication.



Sequential Read Starting from Random Location

Sequential Read Starting from Current Location

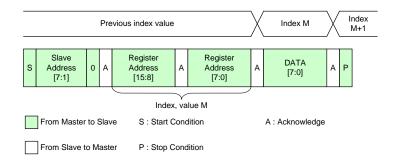
When the index value is known to indicate the address to be read, sending the slave address with a read request allows the data to be read immediately after the Acknowledge. When the Master outputs an Acknowledge after it receives the data, the index value inside the sensor is incremented and the data at the next address is output on SDA. This allows the Master to read data sequentially. After reading the necessary data, the Master generates a Negative Acknowledge and the Stop Condition to end the communication.



Sequential Read Starting from Current Location

Single Write to Random Location

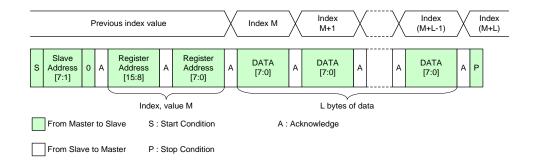
The Master sets the sensor index value to M by designating the sensor slave address with a write request, and designating the address (M). After that the Master can write the value in the designated register by transmitting the data to be written. After writing the necessary data, the Master generates the Stop Condition to end the communication.



Single Write to Random Location

Sequential Write Starting from Random Location

The Master can write a value to register address M by designating the sensor slave address with a write request, designating the address (M), and then transmitting the data to be written. After the sensor receives the write data, it outputs an Acknowledge and at the same time increments the register address, so the Master can write to the next address simply by continuing to transmit data. After the Master writes the necessary number of bytes, it generates the Stop Condition to end the communication.



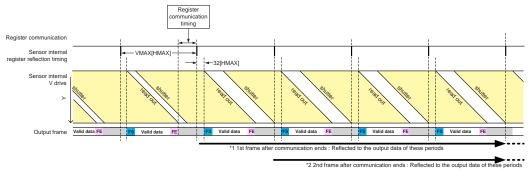
Sequential Write Starting from Random Location

Register Value Reflection Timing to Output Data (CSI-2)

The register values established by register communication are reflected to the output data at the following timings.

Reflection timing	Explanation	
*1 1st frame after	The communication contents are reflected to the output data from	
communication ends	1st frame after communication ends.	
*2 2nd frame after	The communication contents are reflected to the output data from	
communication ends	2nd frame after communication ends.	
Immediately	The communication contents are reflected immediately.	

For which reflection timing of each register, see "Register Map" on pages 39 to 42.



Register Value Reflection Timing to Output Data (CSI-2)

Register Hold Setting (CSI-2)

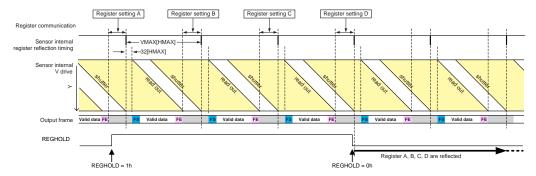
Register setting can be transmitted with divided to several frames and it can be reflected globally at a certain frame by the register REGHOLD for the registers of which reflection timing is frame unit (*1 and *2).

Registers are set when REGHOLD = 1h, and REGHOLD is set to "0h" during communication period just before the frame the registers are reflected from.

Register hold function is invalid for the registers of which reflection timing is immediately. Therefore these registers are reflected immediately when even though REGHOLD = 1h.

REGHOLD Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
REGHOLD	GHOLD 302Dh —	_	[0]	0h	Normal communication Reflecting register setting when register settings are held
			1h	Register setting hold	



Example of REGHOLD operation (CSI-2)

Setting Registers Using Serial Communication (When Using Sub-LVDS)

Setting Registers Using Serial Communication (Sub-LVDS)

Sensor operation is controlled by the register settings. Follow the procedure below and make the register settings by serial communication.

- 1. Set XCE Low to enable the chip's serial communication function.
- 2. Transmit serial data (SDI) synchronized with SCK 1 bit at a time from the lower bits.
- 3. Transmit the Chip ID (fixed value: 81h) in the first byte.
- 4. Transmit the address value of the register to be set in the second and third bytes.
- 5. Transmit the register setting value to the address designated by the second and third bytes in the fourth byte.
- 6. Transmit the register setting value to the address following the address designated by the second and third bytes in the fifth byte.
- 7. Transmit the register setting values to subsequent addresses in order thereafter.
- 8. Set XCE High to end serial communication.

The sensor clears the Chip ID and address setting data by setting XCE High.

Therefore, the Chip ID and address settings must also be made when the next serial communication is performed. Continuous write across upper bytes is prohibited. When writing across upper bytes, first complete the above sequence, and then perform communication again. In addition, when jumping to a discontinuous address, also first complete the above sequence, and then perform communication again.

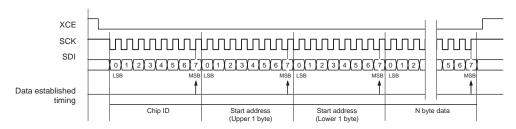
Perform serial communication within the 6XHS period (recommended serial communication period) after the fall of XVS to avoid affecting the image quality.

Settings made by serial communication are basically updated immediately each time 1 byte of setting values is transmitted. However, in some exceptional cases (electronic shutter setting, etc.), register setting values are updated immediately before the start of readout immediately after the recommended serial communication period (7th XHS). For details, see "Register Map" on pages 39 to 42 and "Register Value Reflection Timing to Output Data" on page 38.

Note) 1. Communication is always accepted.

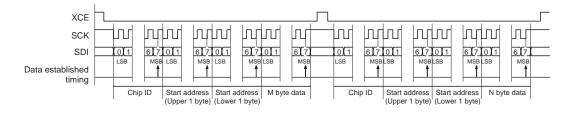
2. Communication should be completed within the recommended serial communication period to prevent noise. However, this restriction does not apply during the readout period of non-picture frames in which noise is ignored (immediately after power-on or immediately after switching the drive mode, etc.), so register communication can be performed other than during the communication period of those frames.

Example of Serial Communication Timing 1



Example of Serial Communication 1

Example of Serial Communication Timing 2



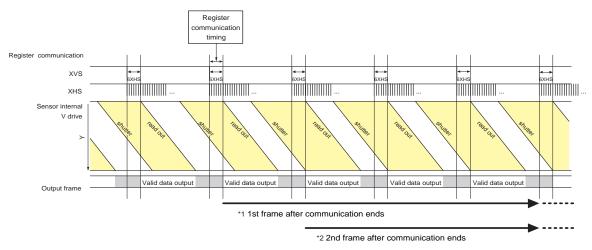
Example of Serial Communication 2

Register Value Reflection Timing to Output Data (Sub-LVDS)

The register values established by register communication are reflected to the output data at the following timings.

Reflection timing	Description
*1 1st frame after	The communication contents are reflected to the output data from the
communication ends	V period during which communication was performed.
*2 2nd frame after	The communication contents are reflected to the output data from the next
communication ends	V period after the V period during which communication was performed.

For which reflection timing of each register, see "Register Map" on pages 39 to 42.



Register Value Reflection Timing to Output Data (Sub-LVDS)

Register Map

Addı	ress	Bit	Default	Reflection			
CSI-2	Sub- LVDS	assign- ment	value	timing	Register name	Function	Remarks
		[0]	1h	Immediately	STANDBY	0h : Normal operation 1h : Overall standby	Setting range: 0h to 1h
		[1]	1h	Immediately	STBLOGIC	Oh: Normal operation 1h: Digital circuit standby other than serial communication block	Setting range: 0h to 1h
3000h	0000h	[2]	0h			_	Set the default value.
		[3]	0h	Immediately	STBMIPI	0h: CSI-2 on 1h: CSI-2 standby	CSI-2: set to 0h Sub-LVDS: set to 1h
		[4]	1h	Immediately	STBDV	0h: Normal operation 1h: Frequency demultiplier standby	Setting range: 0h to 1h
		[7:5]	0h			_	Set the default value.
		[3:0]	0h			_	Set the default value.
3001h	0001h	[4]	0h	*1	CLPSQRST	When changing form 0h to 1h: Resets the internal clamp circuit operation mode	Setting range: 0h to 1h After the reset, the value is automatically returned to 0h.
		[7:5]	0h			_	Set the default value.
_	0002h	[0]	0h	*1	SSBRK	Sub-LVDS only When changing form 0h to 1h: Interrupt enable	Setting range: 0h to 1h After the interrupt, the value is automatically returned to 0h.
		[7:1]	00h			_	Set the default value.
	0003h	[3:0]	7h	*1	STBLVDS	Sub-LVDS only 0h: 10ch, 1h: 8ch, 2h: 6ch, 3h: 4ch, 4h: 2ch, 5h: 1ch 7h: All channel standby	Setting range: 0h to 5h, 7h
_	000311	[7:4]	3h	*1	LANESEL	Sub-LVDS only 0h: 10ch, 1h: 8ch, 2h: 6ch, 3h: 4ch, 4h: 2ch, 5h: 1ch 7h: All channel standby	Setting range: 0h to 5h, 7h
3004h	0004h	[7:0]	03h	*1	MDSEL1	Mode select 1	Set the value according to each readout mode register setting.
3005h	0005h	[7:0]	31h	*1	MDSEL2	Mode select 2	Set the value according to each readout mode register setting.
3006h	0006h	[7:0]	00h	*1	MDSEL3	Mode select 3	Set the value according to each readout mode register setting.
3007h	0007h	[7:0]	09h	*1	MDSEL4	Mode select 4	Set the value according to each readout mode register setting.
3008h	0008h	[0]	0h	*1	SMD	0h: Rolling shutter 1h: Global reset shutter	Setting range: 0h to 1h
		[7:1]	00h			_	Set the default value.
_	0009h	[0]	0h	Immediately	DCKRST	Sub-LVDS only When changing form 0h to 1h: Clock phase reset of Sub-LVDS	Setting range: 0h to 1h After the reset, the value is automatically returned to 0h.
		[7:1]	00h			_	Set the default value.
300Ah	000Ah	[7:0]	000h	*1	PGC	Analog gain setting	Setting range: 000h to 7A5h
300Bh	000Bh	[2:0] [7:3]	00h			_	Set the default value.

Addr	ress	Bit	Default	Reflection			
CSI-2	Sub- LVDS	assign- ment	value	timing	Register name	Function	Remarks
300Ch	000Ch	[7:0]				Specifies the integration start	Setting range is shown
300Dh	000Dh	[7:0]	0008h	*2	SHR	horizontal period	in "Description of Registers"
300Eh	000Eh	[7:0]	0000h	*2	SVR	Specifies the integration shutdown	Setting range:
300Fh	000Fh	[7:0]	000011	2	SVK	vertical period	0000h to FFFFh
3012h	0012h	[3:0]	0h	*1	DGAIN	Digital gain setting 0h: 0dB, 1h: +6dB, 2h: +12dB, 3h: +18dB, 4h: +24dB, 5h: +30dB, 6h: +36dB	Setting range: 0h to 6h
		[7:4]	0h			_	Set the default value.
3018h	_	[1:0]	3h	Immediately	SYNCDRV	CSI-2 only XHS/XVS pulse output enable 2h: XHS/XVS is output 3h: XHS/XVS is Hi-Z	Refer to the "Standby Cancel Sequence" when using XHS/XVS output
		[7:2]	28h			_	Set the default value.
301Ah	001Ah	[0]	0h	*2	MDVREV	Oh : Vertical direction normal readout 1h : Vertical direction inversion readout	Setting range: 0h to 1h
		[7:1]	00h			_	Set the default value.
302Dh	_	[0]	0h	Immediately	REGHOLD	CSI-2 only Register setting hold function	Setting range is shown in "Description of Registers"
		[7:1]	00h			_	Set the default value.
3037h	0037h	[0]	0h	*1	HTRIMMING_ EN	_	Set the value according to each readout mode register setting.
		[7:1]	00h			_	Set the default value.
3038h	0038h	[7:0] [4:0]	00h 00h	*1	HTRIMMING_S TART	_	Set the value according to each readout mode register setting.
3039h	0039h	[7:5]	0h		.,	_	Set the default value.
303Ah	003Ah	[7:0]	00h	4.4	HTRIMMING_		Set the value according to each
303Bh	003Bh	[4:0]	00h	*1	END	_	readout mode register setting.
303011	003611	[7:5]	0h			_	Set the default value.
303Eh	003Eh	[1:0]	2h	Immediately	SYS_MODE	Select use Interface 0h, 1h: Sub-LVDS 2h: MIPI1.44Gbps	Refer to the "Standby Cancel Sequence" Setting range: 0h to 2h
		[7:2]	00h			_	Set the default value.
3045h	0045h	[7:0]	32h	Immediately	BLKLEVEL	Digital black level offset setting	Setting range: 0h to FFh 10-bit readout mode: 1 digit/1h 12-bit readout mode: 4 digit/1h
304Ch	004Ch	[7:0]	10h	Immediately	PLSTMG01	Drive pulse timing setting 01	Set to 00h
304Dh	004Dh	[1:0]	0h	*1	PLSTMG02	Drive pulse timing setting 02	Set to 3h
306Bh	006Bh	[7:0]	07h	Immediately	MDPLS17	_	Set the value according to each readout mode register setting.
30DDh	00DDh	[0]	0h	*1	VWIDCUTEN	_	Set the value according to each readout mode register setting.
		[7:1]	00h			_	Set the default value.
30DEh	00DEh	[7:0]	000h	*1	VWIDCUT	_	Set the value according to each
30DFh	00DFh	[2:0] [7:3]	00h			_	readout mode register setting. Set the default value.
30E0h	00E0h	[7:0]	000h	*1	VWINPOS	_	Set the value according to each
30E1h	00E1h	[3:0] [7:4]	00h			_	readout mode register setting. Set the default value.

Addı	ress	Bit	Default	Reflection			
CSI-2	Sub- LVDS	assign- ment	value	timing	Register name	Function	Remarks
30E2h	00E2h	[7:0]	00h	Immediately	VCUTMODE	Mode setting register	Set the value according to each readout mode register setting.
_	00E6h	[7:0]	00h	Immediately	PLL_CKEN	Sub-LVDS only Clock control setting	Refer to the "Standby Cancel Sequence"
_	00E8h	[7:0]	00h	Immediately	PACKEN	Sub-LVDS only Clock control setting	Refer to the "Standby Cancel Sequence"
30EEh	00EEh	[7:0]	00h	*1	PSMOVEN	Mode setting	Set the value according to each readout mode register setting.
30F4h	_	[0]	1h	Immediately	XMSTA	CSI-2 only Master mode operation 0h: Master mode start 1h: Master mode stop	Refer to the "Standby Cancel Sequence"
		[7:1]	00h			_	Set the default value.
30F6h 30F7h	_ _	[7:0] [7:0]	0104h	*1	HMAX	CSI-2 only Horizontal drive period length	Setting range is shown in "Description of Registers"
30F8h	_	[7:0]				CSI-2 only	Setting range is shown
30F9h 30FAh		[7:0] [3:0]	00905h	*1	VMAX	Vertical drive period length	in "Description of Registers"
30FAh	_	[7:4]	00h			_	Set the default value.
		[0]	1h	immediately	STBPL_IF	PLL standby control register for IF	Refer to the "Standby Cancel Sequence"
310Bh	010Bh	[3:1]	0h			_	Set the default value.
310011	OTOBIT	[4]	1h	immediately	STBPL_AD	PLL standby control register for AD	Refer to the "Standby Cancel Sequence"
		[7:5]	0h			_	Set the default value.
3111h	0111h	[0]	0h	immediately	SLEEP	Low power consumption drive in exposure time	Setting range: 0h to 1h
		[7:1]	00h			_	Set the default value.
3120h 3121h	0120h 0121h	[7:0]	0080h	immediately	PLRD1	Input clock frequency setting register	Setting range is shown in "Description of Registers"
312111 3122h	012111 0122h	[7:0] [7:0]	03h	Immediately	PLRD2	Input clock frequency setting register	Setting range is shown in "Description of Registers"
3129h	0129h	[7:0]	0Dh	immediately	PLRD3	Input clock frequency setting register	Setting range is shown in "Description of Registers"
312Ah	012Ah	[7:0]	00h	immediately	PLRD4	Input clock frequency setting register	Setting range is shown in "Description of Registers"
312Dh	012Dh	[7:0]	03h	immediately	PLRD5	Input clock frequency setting register	Setting range is shown in "Description of Registers"
3130h	_	[7:0]	02E2h	*1	WRITE_VSIZE		Set the value according to each readout mode register setting.
3131h	_	[4:0] [7:5]	0h			—	Set the default value.
3132h	_	[7:0]		4.4	V 0117 0175	CSI-2 only	Set the value according to each
3133h	_	[4:0]	02DEh	*1	Y_OUT_SIZE	Mode setting	readout mode register setting.
		[7:5]	0h			_	Set the default value.
3304h 3305h	_	[7:0] [7:0]	0005h	immediately	PSMIPI1	CSI-2 only Timing setting for CSI-2	Set to 32h
3306h 3307h		[7:0] [7:0]	0005h	immediately	PSMIPI2	CSI-2 only Timing setting for CSI-2	Set to 32h
331Ch 331Dh	031Ch 031Dh	[7:0] [7:0]	0026h	immediately	PLSTMG03	Drive pulse timing setting 03	Set to 001Ah
_	032Ch 032Dh	[7:0] [7:0]	00FFh	immediately	PSLVDS1	Sub-LVDS only Timing setting for Sub-LVDS	Set the value according to each readout mode register setting.
3342h 3343h	0342h 0343h	[7:0] [7:0]	01FFh	immediately	MDPLS01	—	Set the value according to each readout mode register setting.
3344h	0344h	[7:0]	01FFh	immediately	MDPLS02	_	Set the value according to each
3345h 33A6h	0345h 03A6h	[7:0] [7:0]	01h	immediately	MDPLS16	_	readout mode register setting. Set the value according to each
_	034Ah	[7:0]	00FFh	immediately	PSLVDS2	Sub-LVDS only	readout mode register setting. Set the value according to each
	034Bh	[7:0]	33. 1 11		. 027502	Timing setting for Sub-LVDS	readout mode register setting.

Addr	ress	Bit	Default	Reflection			
CSI-2	Sub- LVDS	assign- ment	value	timing	Register name	Function	Remarks
3502h	0502h	[7:0]	03h	*1	PLSTMG04	Drive pulse timing setting 04	Set to 02h
3528h	0528h	[7:0]	0Fh	immediately	MDPLS03	_	Set the value according to each readout mode register setting.
3529h	0529h	[7:0]	0Fh	immediately	PLSTMG05	Drive pulse timing setting 05	Set to 0Eh
352Ah	052Ah	[7:0]	0Fh	immediately	PLSTMG06	Drive pulse timing setting 06	Set to 0Eh
352Bh	052Bh	[7:0]	0Fh	immediately	PLSTMG07	Drive pulse timing setting 07	Set to 0Eh
3538h	0538h	[7:0]	0Fh	immediately	PLSTMG08	Drive pulse timing setting 08	Set to 0Eh
3539h	0539h	[7:0]	0Fh	immediately	PLSTMG09	Drive pulse timing setting 09	Set to 0Eh
3553h	0553h	[7:0]	1Fh	immediately	PLSTMG10	Drive pulse timing setting 10	Set to 00h
3554h	0554h	[7:0]	1Fh	immediately	MDPLS04	_	Set the value according to each readout mode register setting.
3555h	0555h	[7:0]	1Fh	immediately	MDPLS05	_	Set the value according to each readout mode register setting.
3556h	0556h	[7:0]	1Fh	immediately	MDPLS06	_	Set the value according to each readout mode register setting.
3557h	0557h	[7:0]	1Eh	immediately	MDPLS07	_	Set the value according to each readout mode register setting.
3558h	0558h	[7:0]	1Dh	immediately	MDPLS08	_	Set the value according to each readout mode register setting.
3559h	0559h	[7:0]	1Dh	immediately	MDPLS09	_	Set the value according to each readout mode register setting.
355Ah	055Ah	[7:0]	1Ah	immediately	MDPLS10	_	Set the value according to each readout mode register setting.
357Dh	057Dh	[7:0]	0Ch	immediately	PLSTMG11	Drive pulse timing setting 11	Set to 05h
357Fh	057Fh	[7:0]	08h	immediately	PLSTMG12	Drive pulse timing setting 12	Set to 05h
3581h	0581h	[7:0]	02h	immediately	PLSTMG13	Drive pulse timing setting 13	Set to 04h
3583h	0583h	[7:0]	51h	immediately	PLSTMG14	Drive pulse timing setting 14	Set to 76h
3587h	0587h	[7:0]	00h	*1	PLSTMG15	Drive pulse timing setting 15	Set to 01h
3590h 3591h	_	[7:0] [7:0]	0005h	immediately	PSMIPI3	CSI-2 only Timing setting for CSI-2	Set to 32h
_	05B6h 05B7h	[7:0] [7:0]	00FFh	immediately	PSLVDS3	Sub-LVDS only Timing setting for Sub-LVDS	Set the value according to each readout mode register setting
_	05B8h 05B9h	[7:0] [7:0]	00FAh	immediately	PSLVDS4	Sub-LVDS only Timing setting for Sub-LVDS	Set the value according to each readout mode register setting
35BAh	05BAh	[7:0]	0Fh	immediately	MDPLS11	_	Set the value according to each readout mode register setting.
35BBh	05BBh	[7:0]	0Fh	immediately	PLSTMG16	Drive pulse timing setting 16	Set to 0Eh
35BCh	05BCh	[7:0]	0Fh	immediately	PLSTMG17	Drive pulse timing setting 17	Set to 0Eh
35BDh	05BDh	[7:0]	0Fh	immediately	PLSTMG18	Drive pulse timing setting 18	Set to 0Eh
35BEh	05BEh	[7:0]	0Fh	immediately	PLSTMG19	Drive pulse timing setting 19	Set to 0Eh
35BFh	05BFh	[7:0]	0Fh	immediately	PLSTMG20	Drive pulse timing setting 20	Set to 0Eh
366Ah	066Ah	[7:0]	10h	immediately	MDPLS12	_	Set the value according to each readout mode register setting.
366Bh	066Bh	[7:0]	0Eh	immediately	MDPLS13	_	Set the value according to each readout mode register setting.
366Ch	066Ch	[7:0]	0Ch	immediately	MDPLS14	_	Set the value according to each readout mode register setting.
366Dh	066Dh	[7:0]	0Ah	immediately	MDPLS15	_	Set the value according to each readout mode register setting.
366Eh	066Eh	[7:0]	08h	immediately	PLSTMG21	Drive pulse timing setting 21	Set to 00h
366Fh	066Fh	[7:0]	06h	immediately	PLSTMG22	Drive pulse timing setting 22	Set to 00h
3670h	0670h	[7:0]	04h	immediately	PLSTMG23	Drive pulse timing setting 23	Set to 00h
3671h	0671h	[7:0]	02h	immediately	PLSTMG24	Drive pulse timing setting 24	Set to 00h
3686h 3687h	_	[7:0] [7:0]	0004h	immediately	PSMIPI4	CSI-2 only Timing setting for CSI-2	Set to 32h
3A41h	_	[5:0]	04h	*1	MDSEL5	CSI-2 only Mode setting	Set the value according to each readout mode register setting.
		[7:6]	0h			_	Set the default value.

1. Description of Register

Total Standby Control (CSI-2 and Sub-LVDS)

All sensor operation is stopped and the standby mode that reduces power consumption is established by setting the overall standby control register STANDBY to "1h".

(Standby mode is established immediately after reset.)

The serial communication block operates even in standby mode, so standby mode can be canceled by setting "0h" in the STANDBY register.

STANDBY Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
STANDBY	3000h	00006	[0]	0h	Normal operation
STAINDET	300011	0000h	[0]	1h	Overall standby

Digital Circuit Standby Control (CSI-2 and Sub-LVDS)

When power-on, set the digital circuit standby control register STBLOGIC according to the standby cancel sequence. This register is valid only when STANDBY = 0h.

STBLOGIC Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
				0h	Normal operation
STBLOGIC	3000h	0000h	[1]	1h	Digital circuit standby other than serial
				111	communications block

Frequency Demultiplier Standby Control (CSI-2 and Sub-LVDS)

When power-on, set the frequency demultiplier standby control register STBDV according to the standby cancel sequence. This register is valid only when STANDBY = 0h.

STBDV Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
STBDV	3000h	0000h	[4]	0h	Normal operation
SIDDA	300011	UUUUN	[4]	1h	Frequency demultiplier standby

Clamp Reset (CSI-2 and Sub-LVDS)

The internal clamp circuit operation status is reset by the clamp reset register CLPSQRST. Make this setting according to the recommended sequence during power-on or when canceling standby mode.

This register automatically returns to "0h" after the reset process, so there is no need to write "0h".

CLPSQRST Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
CLPSQRST	3001h	0001h	[4]	Changed from 0h to 1h	Resets the internal clamp circuit operation status

Input Frequency Setting (CSI-2 and Sub-LVDS)

The input clock frequency can be set arbitrarily by setting input clock setting register PLRD1, PLRD2, PLRD3, PLRD4 and PLRD5.

Set this registers according to the recommended sequence during power-on or when canceling standby mode.

Input Frequency Setting Registers

Name	CSI-2 Address	Sub-LVDS Address	Bit	Function
PLRD1 [7:0]	3120h	0120h	[7:0]	Input clock frequency setting register
PLRD1 [15:8]	3121h	0121h	[7:0]	Input clock frequency setting register
PLRD2 [7:0]	3122h	0122h	[7:0]	Input clock frequency setting register
PLRD3 [7:0]	3129h	0129h	[7:0]	Input clock frequency setting register
PLRD4 [7:0]	312Ah	012Ah	[7:0]	Input clock frequency setting register
PLRD5 [7:0]	312Dh	012Dh	[7:0]	Input clock frequency setting register

PLRD1 to PLRD5 Setting (CSI-2)

			R	egister valu	ıe	
		PLRD1	PLRD2	PLRD3	PLRD4	PLRD5
Input	6	00F0h	00h	9Ch	00h	02h
clock	12	00F0h	01h	9Ch	01h	02h
frequency	18	00A0h	01h	68h	01h	02h
[MHz]*1	24	00F0h	02h	9Ch	02h	02h

^{*1} Consult your Sony sales representative concerning other input frequency settings.

PLRD1 to PLRD5 Setting (Sub-LVDS)

			R	egister valu	ıe	
		PLRD1	PLRD2	PLRD3	PLRD4	PLRD5
Input	12	00C0h	01h	9Ch	01h	02h
clock	24	00C0h	02h	9Ch	02h	02h
frequency	36	0080h	02h	68h	02h	02h
[MHz]*1	72	0080h	03h	68h	03h	02h

¹ Consult your Sony sales representative concerning other input frequency settings.

Vertical Direction Readout Inversion (CSI-2 and Sub-LVDS)

The direction of vertical readout order can be set by the vertical direction readout inversion register MDVREV. See "Optical Black Array and Readout Scan Direction" for details of readout image.

MDVREV Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
MDVREV	301Ah	001Ah	[0]	0h	Vertical direction normal readout
MDVKEV	301AII	00 IAII	[0]	1h	Vertical direction inversion readout

Analog Gain (CSI-2 and Sub-LVDS)

The analog gain value can be set by setting the analog gain register PGC. Set the lower 8 bits and the upper 3 bits, for total of 11 bits.

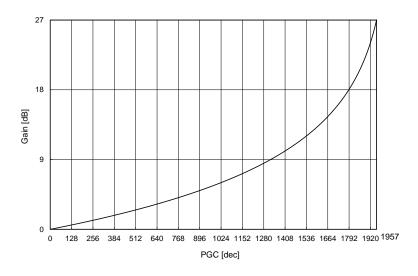
PGC Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
PGC [7:0]	300Ah	000Ah	[7:0]	0h to 7A5h	Analog gain setting
PGC [10:8]	300Bh	000Bh	[2:0]	(0d to 1957d)	Analog gain setting

In addition, the figure below shows the relationship between the register setting value and the gain value. When the register setting value is "0h (0d)", the gain value is 0 dB (minimum settable value), and when "7A5h (1957d)", the gain value is approximately 27 dB (maximum settable value).

Relation Formula

Gain [dB] = $-20\log\{(2048 - PGC [10:0])/2048\}$



Relationship between Register Setting Value and Set Gain Value

Digital Gain (CSI-2 and Sub-LVDS)

The digital gain applied to the data after pixel binning can be set by the digital gain setting register DGAIN.

DGAIN Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
			0h	Digital gain setting value = 0 dB	
				1h	Digital gain setting value = +6 dB
				1	2h
DGAIN [3:0]	3012h	0012h	[3:0]	3h	Digital gain setting value = +18 dB
					4h
				5h	Digital gain setting value = +30 dB
				6h	Digital gain setting value = +36 dB

Digital Black Level Offset (CSI-2 and Sub-LVDS)

The black level offset applied to the data after digital gain processing by the DGAIN register is set by the digital black level offset setting register BLKLEVEL.

Note that the offset unit changes according to the readout drive mode.

When the output data length is 10-bit output, increasing the register setting value by 1h increases the black level by 1 digit. When the output data length is 12-bit output, increasing the register setting value by 1h increases the black level by 4 digits.

BLKLEVEL Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
BLKLEVEL [7:0]	3045h	0045h	[0]	00h to FFh	Digital black level offset setting

Readout Drive Pulse Timing (CSI-2 and Sub-LVDS)

When power-on, set the readout drive pulse timing registers, PLSTMG01 to 23 for both CSI-2 and Sub-LVDS and PSMIPI1 to 4 for CSI-2 only, which are shown in the following table as the initialization registers. See the standby cancel sequence for timing of sending.

PLSTMG Setting for CSI-2 and Sub-LVDS

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value
PLSTMG01	304Ch	004Ch	[7:0]	Set to 00h
PLSTMG02	304Dh	004Dh	[7:0]	Set to 3h
	331Ch	031Ch	[7:0]	
PLSTMG03	331Dh	031Dh	[7:0]	Set to 001Ah
PLSTMG04	3502h	0502h	[7:0]	Set to 02h
PLSTMG05	3529h	0529h	[7:0]	Set to 0Eh
PLSTMG06	352Ah	052Ah	[7:0]	Set to 0Eh
PLSTMG07	352Bh	052Bh	[7:0]	Set to 0Eh
PLSTMG08	3538h	0538h	[7:0]	Set to 0Eh
PLSTMG09	3539h	0539h	[7:0]	Set to 0Eh
PLSTMG10	3553h	0553h	[7:0]	Set to 00h
PLSTMG11	357Dh	057Dh	[7:0]	Set to 05h
PLSTMG12	357Fh	057Fh	[7:0]	Set to 05h
PLSTMG13	3581h	0581h	[7:0]	Set to 04h
PLSTMG14	3583h	0583h	[7:0]	Set to 76h
PLSTMG15	3587h	0587h	[7:0]	Set to 01h
PLSTMG16	35BBh	05BBh	[7:0]	Set to 0Eh
PLSTMG17	35BCh	05BCh	[7:0]	Set to 0Eh
PLSTMG18	35BDh	05BDh	[7:0]	Set to 0Eh
PLSTMG19	35BEh	05BEh	[7:0]	Set to 0Eh
PLSTMG20	35BFh	05BFh	[7:0]	Set to 0Eh
PLSTMG21	366Eh	066Eh	[7:0]	Set to 00h
PLSTMG22	366Fh	066Fh	[7:0]	Set to 00h
PLSTMG23	3670h	0670h	[7:0]	Set to 00h
PLSTMG24	3671h	0671h	[7:0]	Set to 00h

PSMIPI Setting for CSI-2

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value
PSMIPI1 [7:0]	3304h	_	[7:0]	Set to 32h
PSMIPI1 [15:8]	3305h	_	[7:0]	Set to 3211
PSMIPI2 [7:0]	3306h	_	[7:0]	Set to 32h
PSMIPI2 [15:8]	3307h	_	[7:0]	Set to 3211
PSMIPI3 [7:0]	3590h	_	[7:0]	Set to 32h
PSMIPI3 [15:8]	3591h	_	[7:0]	Set to 3211
PSMIPI4 [7:0]	3686h	_	[7:0]	Set to 32h
PSMIPI4 [15:8]	3687h	_	[7:0]	3et to 32ff



Sleep (CSI-2 and Sub-LVDS)

SLEEP register reduces the power consumption during the integration time. See "Low Power Consumption Drive in Integration Time When Using Rolling Shutter Operation" and "Low Power Consumption Drive in Exposure Time When Using Global Reset Shutter Operation".

SLEEP Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
SLEEP	3111h	0111h	[0]	0h	Normal operation
SLEEP	311111	011111	[0]	1h	Circuit standby

PLL Standby Control (CSI-2 and Sub-LVDS)

When power-on, set the PLL standby control registers STBPL_IF and STBPL_AD according to the standby cancel sequence. These registers are valid only when STANDBY = 0h.

STBPL_IF and STBPL_AD Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Function
STBPL_IF	310Bh	010Bh	[0]	PLL standby control register for IF
STBPL_AD	310Bh	010Bh	[4]	PLL standby control register for AD

CSI-2 Standby Control (CSI-2 only)

CSI-2 can be standby by CSI-2 standby register STBMIPI.

STBMIPI Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
STBMIPI	2000h		[0]	0h	Normal operation
SIBIVIIPI	3000h —		[3]	1h	CSI-2 standby

Master Mode Operation Control (CSI-2 only)

When power-on, set the master mode operation control register XMSTA according to the standby cancel sequence. This register is valid only when STANDBY = 0h.

XMSTA Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
XMSTA	30F4h		[0]	0h	Master mode start
VINIZIA	30F411	_	[0]	1h	Master mode stop



Horizontal Drive Period Length and Vertical Drive Period Length (CSI-2 only)

When using CSI-2, Horizontal drive period length (Unit: Number of 72MHz clock) and vertical drive period length (Unit: Number of horizontal drive period) can be set by horizontal drive period length setting register HMAX and vertical drive period length setting register VMAX.

HMAX, VMAX Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
HMAX [7:0]	30F6h	_	[7:0]	Setting range is shown	
HMAX [15:8]	30F7h	_	[7:0]	in "Description of Registers"	Horizontal drive period length
VMAX [7:0]	30F8h	_	[7:0]	Setting range is shown	
VMAX [15:8]	30F9h	_	[7:0]	in "Description of	Vertical drive period length
VMAX [19:16]	30FAh	_	[3:0]	Registers"	

Calculating formula of vertical drive period (1 frame) is shown below.

Vertical drive period length [s] = VMAX value \times (SVR value + 1) \times HMAX value/ (72 \times 10⁶)

See "Horizontal/Vertical Operation Period in Each Readout Drive Mode" on page 62 for setting range of HMAX and VMAX in each readout mode, and example of standard setting.

Break Mode (Sub-LVDS only)

XVS can be subsampled according to SVR. This XVS subsampling operation can be stopped and then restarted from the start of the exposure period using the break mode register SSBRK (address 0002h, bit [0]). This register automatically returns to "0h" after the break process, so there is no need to write "0h".

SSBRK Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
SSBRK	_	0002h	[0]	Change from 0h to 1h	Interrupt enable

Sub-LVDS Clock Output Phase Fixed (Sub-LVDS only)

The clock phase relative to the sync code start data in the Sub-LVDS data output is fixed by the Sub-LVDS clock output phase fixing register DCKRST. Make this setting according to the recommended sequence during power-on or when canceling standby mode.

This register automatically returns to "0h" after the phase fixing process, so there is no need to write "0h".

DCKRST Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
DCKRST	_	0009h	[0]	Change from 0h to 1h	Clock phase reset of Sub-LVDS

Sub-LVDS Standby Control (Sub-LVDS only)

This sensor can set the Sub-LVDS to standby mode according to the setting value by setting the Sub-LVDS standby control register STBLVDS.

STBLVDS Setting

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
				0h	10 ch
	_	0003h		1h	8 ch
CTDL\/DC				2h	6 ch
STBLVDS [3:0]			[3:0]	3h	4 ch
[3.0]				4h	2 ch
				5h	1 ch
				Fh	All channel standby

Sub-LVDS Standby Control (Sub-LVDS only)

dec	bin	hex	Function	DLO0	DLO1	DLO2	DLO3	DLO4	DLCK	DLO5	DLO6	DLO7	DLO8	DLO9
STBI	STBLVDS[3:0]													
0d	0000b	0h	10 ch	Active										
1d	0001b	1h	8 ch	Active	Active	Active	STBY	Active	Active	Active	STBY	Active	Active	Active
2d	0010b	2h	6 ch	STBY	Active	Active	STBY	Active	Active	Active	STBY	Active	Active	STBY
3d	0011b	3h	4 ch	STBY	STBY	Active	STBY	Active	Active	Active	STBY	Active	STBY	STBY
4d	0100b	4h	2 ch	STBY	STBY	STBY	STBY	Active	Active	Active	STBY	STBY	STBY	STBY
5d	0101b	5h	1 ch	STBY	STBY	STBY	STBY	Active	Active	STBY	STBY	STBY	STBY	STBY
15d	1111b	Fh	All Standby	STBY										

Number of LVDS Output Channels Selection (Sub-LVDS only)

This sensor can set the number of output channels according to the setting value by setting the number of Sub-LVDS output channels selection register LANESEL.

LANESEL Setting (Sub-LVDS only)

Name	CSI-2 Address	Sub-LVDS Address	Bit	Register value	Function
				0h	10 ch
	_	0003h	[7:4]	1h	8 ch
LANESEL				2h	6 ch
[3:0]				3h	4 ch
				4h	2 ch
			i	5h	1 ch

Number of Sub-LVDS Channels Control (Sub-LVDS only)

dec	bin	hex	Function	DLO0	DLO1	DLO2	DLO3	DLO4	DLCK	DLO5	DLO6	DLO7	DLO8	DLO9
LANI	LANESEL[3:0]													
0d	0000b	0h	10 ch	Active	Active	Active	Active	Active	Active	Active	Active	Active	Active	Active
1d	0001b	1h	8 ch	Active	Active	Active	Fixed Low	Active	Active	Active	Fixed Low	Active	Active	Active
2d	0010b	2h	6 ch	Fixed Low	Active	Active	Fixed Low	Active	Active	Active	Fixed Low	Active	Active	Fixed Low
3d	0011b	3h	4 ch	Fixed Low	Fixed Low	Active	Fixed Low	Active	Active	Active	Fixed Low	Active	Fixed Low	Fixed Low
4d	0100b	4h	2 ch	Fixed Low	Fixed Low	Fixed Low	Fixed Low	Active	Active	Active	Fixed Low	Fixed Low	Fixed Low	Fixed Low
5d	0101b	5h	1 ch	Fixed Low	Fixed Low	Fixed Low	Fixed Low	Active	Active	Fixed Low	Fixed Low	Fixed Low	Fixed Low	Fixed Low



2. Register Setting for Each Readout Drive Mode

The register setting for each readout drive mode available with this sensor is shown in the table below. These registers should be change according to the mode to use. Set the register to the following value.

Description of Register Setting for Each Readout Drive Mode (CSI-2)

Address	Bit	Register				Readou	ıt mode No.	*1		
(CSI-2)	Assign ment	Name	0	1	2	3	4	5	6	7
3004h	[7:0]	MDSEL1	00h	01h	00h	01h	00h	01h	00h	01h
3005h	[7:0]	MDSEL2	07h	01h	07h	01h	07h	01h	07h	01h
3006h	[7:0]	MDSEL3	00h	00h	00h	00h	00h	00h	00h	00h
3007h	[7:0]	MDSEL4	02h	02h	A2h	A2h	A2h	A2h	02h	02h
300Eh	[7:0]	SVR			,	According	to exposure	time		
300Fh	[7:0]	SVK			(S	ee "Frame	Rate Adjus	tment")		
[0] MDVREV Oh: vertical direction normal /1h: inverted								d		
301711	[7:1]						00h			
3037h	[7:0]	HTRIMMING _EN	01h	01h	01h	01h	01h	01h	01h	01h
3038h	[7:0]	HTRIMMING	0180h	0180h	0270h	0270h	0180h	0180h	0348h	0348h
3039h	[4:0]	_START								
303311	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h
303Ah	[7:0]	HTRIMMING	0D98h	0D98h	0CA8h	0CA8h	0D98h	0D98h	0BD0h	0BD0h
303Bh	[4:0]	_END	009611	009011	UCAGII	UCAGII	009011	ODSOII	OBDOIL	OBDOIL
JOODII	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h
306Bh	[7:0]	MDPLS17	07h	05h	07h	05h	07h	05h	07h	05h
30DDh	[7:0]	VWIDCUTEN	00h	00h	01h	01h	01h	01h	00h	00h
30DEh	[7:0]	VWIDCUT	00h	00h	6Ch	6Ch	D8h	D8h	00h	00h
30DFh	[2:0]	VWIDCUT	OOH	UUII	OCII	OCII	Doll	Doll	OOH	OON
300111	[7:3]		0h	0h	0h	0h	0h	0h	0h	0h
30E0h	[7:0]	VWINPOS	00h	00h	36h ^{*3}	36h ^{*3}	6Ch ^{*3}	6Ch ^{*3}	00h	00h
30E1h	[3:0]				FCAh*4	FCAh*4	F94h ^{*4}	F94h ^{*4}		
OOLIII	[7:4]		0h	0h	0h	0h	0h	0h	0h	0h
30E2h	[7:0]	VCUTMODE	00h	01h	00h	01h	00h	01h	00h	01h
30F6h	[7:0]	LINAAV		Catti			ملاسم ما امم سالم	/70ML I= al	(+) *2	
30F7h	[7:0]	HMAX		Settir	ig nonzom	.ai urive pe	eriod length	(1 ZIVIMZ CI	ock unit)	
30F8h	[7:0]									
30F9h	[7:0]	VMAX		Setting	vertical dri	ve period l	ength (unit:	HMAX ×72	2MHz clock)	*
30FAh	[3:0]									
0017111	[7:4]		0h	0h	0h	0h	0h	0h	0h	0h

Address	Bit	Register				Readou	t mode No.	*1		
(CSI-2)	Assign ment	Name	0	1	2	3	4	5	6	7
30EEh	[7:0]	PSMOVEN	1h	1h	1h	1h	1h	1h	1h	1h
3130h	[7:0]	WRITE_	00 4 4 h	000ch	07D2h	07.4Fb	06546	06Deb	00446	00066
3131h	[4:0]	VSIZE	08AAh	0886h	07D2h	07AEh	06FAh	06D6h	08AAh	0886h
313111	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h
3132h	[7:0]	Y_OUT_	089Ah	087Eh	07C2h	07A6h	06EAh	06CEh	089Ah	087Eh
3133h	[4:0]	SIZE	003/11	007 L11	070211	O7 Aoii	OOLAH	OOOLII	003AII	007 LII
010011	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h
3342h	[7:0]	MDPLS01	01FFh	000Ah	01FFh	000Ah	01FFh	000Ah	01FFh	000Ah
3343h	[7:0]	WIDT LOOT	011111	000/111	011111	0007111	011111	0007111	011111	000/111
3344h	[7:0]	MDPLS02	01FFh	0016h	01FFh	0016h	01FFh	0016h	01FFh	0016h
3345h	[7:0]	WIDT LOOP	011111	001011	011111	001011	011111	001011	011111	001011
33A6h	[7:0]	MDPLS16	01h	01h	01h	01h	01h	01h	01h	01h
3528h	[7:0]	MDPLS03	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh
3554h	[7:0]	MDPLS04	00h	1Fh	00h	1Fh	00h	1Fh	00h	1Fh
3555h	[7:0]	MDPLS05	00h	01h	00h	01h	00h	01h	00h	01h
3556h	[7:0]	MDPLS06	00h	01h	00h	01h	00h	01h	00h	01h
3557h	[7:0]	MDPLS07	00h	01h	00h	01h	00h	01h	00h	01h
3558h	[7:0]	MDPLS08	00h	01h	00h	01h	00h	01h	00h	01h
3559h	[7:0]	MDPLS09	1Fh	00h	1Fh	00h	1Fh	00h	1Fh	00h
355Ah	[7:0]	MDPLS10	1Fh	00h	1Fh	00h	1Fh	00h	1Fh	00h
35BAh	[7:0]	MDPLS11	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh
366Ah	[7:0]	MDPLS12	00h	1Bh	00h	1Bh	00h	1Bh	00h	1Bh
366Bh	[7:0]	MDPLS13	00h	1Ah	00h	1Ah	00h	1Ah	00h	1Ah
366Ch	[7:0]	MDPLS14	00h	19h	00h	19h	00h	19h	00h	19h
366Dh	[7:0]	MDPLS15	00h	17h	00h	17h	00h	17h	00h	17h
2 / / /	[5:0]	MDSEL5	10h	08h	10h	08h	10h	08h	10h	08h
3A41h	[7:6]		0h	0h	0h	0h	0h	0h	0h	0h

See "Readout Drive Modes" on pages 55 for details of readout mode No.

See "Horizontal/Vertical Operation Period in Each Readout Drive Mode" on page 62 and "Frame Rate Adjustment" on pages 63 for setting range of HMAX and VMAX in each readout mode, and example of standard setting.

^{*3,4} When MDVREV = 0h , set the *3 value.
When MDVREV = 1h , set the *4 value.

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Description of Register Setting for Each Readout Drive Mode (Sub-LVDS)

Address	Bit	Dogistar	Readout mode No. *1										
(Sub- LVDS)	Assign ment	Register Name	0	1	2	3	4	5	6	7			
0003h	[3:0]	STBLVDS	2h	0h	2h	0h	2h	0h	2h	0h			
000311	[7:4]	LANESEL	2h	0h	2h	0h	2h	0h	2h	0h			
0004h	[7:0]	MDSEL1	00h	00h	00h	00h	00h	00h	00h	00h			
0005h	[7:0]	MDSEL2	07h	01h	07h	01h	07h	01h	07h	01h			
0006h	[7:0]	MDSEL3	00h	00h	00h	00h	00h	00h	00h	00h			
0007h	[7:0]	MDSEL4	02h	02h	A2h	A2h	A2h	A2h	02h	02h			
000Eh	[7:0]	SVR		According to exposure time									
000Fh	[7:0]	SVIC			(See	"Frame Ra	ate Adjustn	nent")					
001Ah	[0]	MDVREV			0h: vertica	al direction	normal /1h	n: inverted					
OOTAIT	[7:1]					00)h						
0037h	[7:0]	HTRIMMING _EN	01h	01h	01h	01h	01h	01h	01h	01h			
0038h	[7:0]	HTRIMMING	04001	0.4.0.01	0070	0070	04001	04001	00.401	00.401			
	[4:0]	_START	0180h	0180h	0270h	0270h	0180h	0180h	0348h	0348h			
0039h	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h			
003Ah	[7:0]	HTRIMMING											
003Bh	[4:0]	_END	0D98h	0D98h	0CA8h	0CA8h	0D98h	0D98h	0BD0h	0BD0h			
000211	[7:5]		0h	0h	0h	0h	0h	0h	0h	0h			
006Bh	[7:0]	MDPLS17	07h	05h	07h	05h	07h	05h	07h	05h			
00DDh	[7:0]	VWIDCUTEN	00h	00h	01h	01h	01h	01h	00h	00h			
00DEh	[7:0]	VWIDCUT	00h	00h	6Ch	6Ch	D8h	D8h	00h	00h			
00DFh	[2:0]	VWIDCOT	0011	0011	OCII	0011	Don	Don	0011	0011			
OODITI	[7:3]		0h	0h	0h	0h	0h	0h	0h	0h			
00E0h	[7:0]	VWINPOS	00h	00h	36h ^{*2}	36h ^{*2}	6Ch ^{*2}	6Ch ^{*2}	00h	00h			
00E1h	[3:0]	VVIINFOS	0011	0011	FCAh ^{*3}	FCAh*3	F94h ^{*3}	F94h ^{*3}	0011	0011			
OOLIII	[7:4]		0h	0h	0h	0h	0h	0h	0h	0h			
00E2h	[7:0]	VCUTMODE	00h	00h	00h	00h	00h	00h	00h	00h			
00EEh	[7:0]	PSMOVEN	1h	1h	1h	1h	1h	1h	1h	1h			
032Ch	[7:0]	PSLVDS1			Set to	o (XVS per	iod[XHS] _	- 32h)					
032Dh	[7:0]	1 027501		ı	00.10	, , , , , o poi		<i>52</i> 11 <i>)</i>	I	ı			
0342h	[7:0]	MDPLS01	01FFh	000Ah	01FFh	000Ah	01FFh	000Ah	01FFh	000Ah			
0343h	[7:0]	MIDI LOUT		000/111	V 11 111	000/111	VIII III	000/111	V 11 111	000/111			
0344h	[7:0]	MDPLS02	01FFh	0016h	01FFh	0016h	01FFh	0016h	01FFh	0016h			
0345h	[7:0]			23.311		23.311		23.311					

Address	Bit	Dogistor				Readout m	node No. *1					
(Sub- LVDS)	Assign ment	Register Name	0	1	2	3	4	5	6	7		
034Ah	[7:0]	PSLVDS2			Sat to	ot to (V)/S pariod(VHS) 32h)						
034Bh	[7:0]	F3LVD32	Set to (XVS period[XHS] – 32h)									
03A6h	[7:0]	MDPLS16	01h	01h	01h	01h	01h	01h	01h	01h		
0528h	[7:0]	MDPLS03	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh		
0554h	[7:0]	MDPLS04	00h	1Fh	00h	1Fh	00h	1Fh	00h	1Fh		
0555h	[7:0]	MDPLS05	00h	01h	00h	01h	00h	01h	00h	01h		
0556h	[7:0]	MDPLS06	00h	01h	00h	01h	00h	01h	00h	01h		
0557h	[7:0]	MDPLS07	00h	01h	00h	01h	00h	01h	00h	01h		
0558h	[7:0]	MDPLS08	00h	01h	00h	01h	00h	01h	00h	01h		
0559h	[7:0]	MDPLS09	1Fh	00h	1Fh	00h	1Fh	00h	1Fh	00h		
055Ah	[7:0]	MDPLS10	1Fh	00h	1Fh	00h	1Fh	00h	1Fh	00h		
05B6h	[7:0]	DCL \/DC2			Catt	- (V)/C	: a d[V 101	201-)				
05B7h	[7:0]	PSLVDS3			Set to	o (XVS per	100[XHS] -	- 32N)				
05B8h	[7:0]	DCLV/DC4			Cat to	. (V\/C nor	iod[VUC]	22h)				
05B9h	[7:0]	PSLVDS4			Section	o (XVS per	100[AHS] -	- 3211)				
05BAh	[7:0]	MDPLS11	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh	0Fh	0Eh		
066Ah	[7:0]	MDPLS12	00h	1Bh	00h	1Bh	00h	1Bh	00h	1Bh		
066Bh	[7:0]	MDPLS13	00h	1Ah	00h	1Ah	00h	1Ah	00h	1Ah		
066Ch	[7:0]	MDPLS14	00h	19h	00h	19h	00h	19h	00h	19h		
066Dh	[7:0]	MDPLS15	00h	17h	00h	17h	00h	17h	00h	17h		

 $^{^{*1}}$ See "Readout Drive Modes" on pages 55 for details of readout mode No *2,3 When MDVREV = 0h , set the *2 value. When MDVREV = 1h, set the *3 value.

Readout Drive Modes (CSI-2 and Sub-LVDS)

1. Readout Drive Modes

The table below describes the readout drive modes that can be used to operate this sensor.

All of the modes listed in the table below support vertical direction inversion operation (MDVREV = 0h/1h).

Description of Readout Drive Modes

Readout Mode No.	Readout drive mode	Mode description
0	All-pixel scan mode (12-bit)	All pixels are readout with 12-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
1	All-pixel scan mode (10-bit)	All pixels are readout with 10-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
2	4:3 crop scan mode (12-bit)	2592 × 1944 pixels are readout with 12-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
3	4:3 crop scan mode (10-bit)	2592 × 1944 pixels are readout with 10-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
4	16:9 crop scan mode (12-bit)	3072 × 1728 pixels are readout with 12-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
5	16:9 crop scan mode (10-bit)	3072 × 1728 pixels are readout with 10-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
6	1:1 crop scan mode (12-bit)	2160 × 2160 pixels are readout with 12-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.
7	1:1 crop scan mode (10-bit)	2160 × 2160 pixels are readout with 10-bit output. This mode can be used together with the global reset shutter function according to the SMD register setting.

Imaging Conditions in Each Readout Drive Mode (CSI-2)

			lm	aging conditions		
Readout mode No.	Number of MIPI output lanes [lane]	Number of A/D conversion bits [bit]	Output data bit length [bit]	Number of horizontal recording pixels	Number of vertical recording pixels	Number of recording pixels
0	4	12	12	3072	2160	Approximately 6.64 M Pixels
1	4	10	10	3072	2160	Approximately 6.64 M Pixels
2	4	12	12	2592	1944	Approximately 5.04 M Pixels
3	4	10	10	2592	1944	Approximately 5.04 M Pixels
4	4	12	12	3072	1728	Approximately 5.31 M Pixels
5	4	10	10	3072	1728	Approximately 5.31 M Pixels
6	4	12	12	2160	2160	Approximately 4.67 M Pixels
7	4	10	10	2160	2160	Approximately 4.67 M Pixels

Imaging Conditions in Each Readout Drive Mode (Sub-LVDS)

			lm	aging conditions		
Readout mode No.	Number of Sub-LVDS output channels [ch]	Number of A/D conversion bits [bit]	Output data bit length [bit]	Number of horizontal recording pixels	Number of vertical recording pixels	Number of recording pixels
0	6	12	12	3072	2160	Approximately 6.64 M Pixels
1	10	10	10	3072	2160	Approximately 6.64 M Pixels
2	6	12	12	2592	1944	Approximately 5.04 M Pixels
3	10	10	10	2592	1944	Approximately 5.04 M Pixels
4	6	12	12	3072	1728	Approximately 5.31 M Pixels
5	10	10	10	3072	1728	Approximately 5.31 M Pixels
6	6	12	12	2160	2160	Approximately 4.67 M Pixels
7	10	10	10	2160	2160	Approximately 4.67 M Pixels

2. Relationship between Arithmetic Processing and the Number of Output Bits in Each Readout Drive Mode

The table below shows the relationship between the A/D conversion resolution and number of output bits in each readout mode.

Note that the number of output bits differs in each mode. In addition the number of output bits is 10 bits. So the weight of 1 digit is 4 times greater than during 12-bit output.

Relationship between Arithmetic Processing and the Number of Output Bits in Each Readout Drive Mode

Readout mode No.	A/D conversion resolution	Number of output bits
0	12 bits	10 bits + 2 bits *1
1	10 bits	10 bits
2	12 bits	10 bits + 2 bits *1
3	10 bits	10 bits
4	12 bits	10 bits + 2 bits *1
5	10 bits	10 bits
6	12 bits	10 bits + 2 bits *1
7	10 bits	10 bits

A/D conversion is performed with a resolution 4 times that of 10-bit A/D conversion, and the results are output in 12 bits regarded as a 10-bit integer item and a 2-bit decimal item.

Image Data Output Format When Using CSI-2

Frame Format (CSI-2)

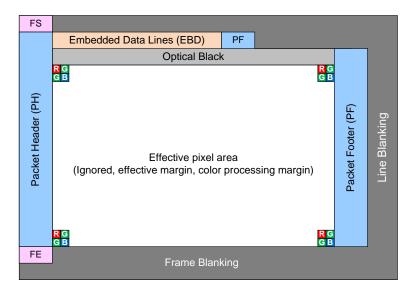
Each line of each image frame is output like the General Frame Format to CSI-2. The settings for each packet header are shown below.

DATA Type

Header [5:0]	Name	Description		
00h	Frame Start Code	FS		
01h	Frame End Code	FE		
12h	Embedded Data	Embedded data		
2Bh	RAW10	When output data bit length is 10-bits		
2Ch	RAW12	When output data bit length is 12-bits		
37h	Optical Black Data	Vertical Optical Black line data		

Frame Structure (CSI-2)

The figure below shows the image frame structure.

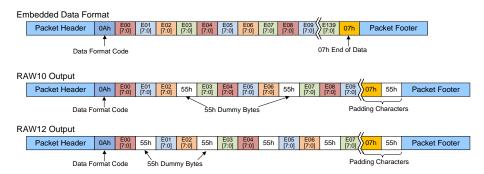


Frame Structure (CSI-2)

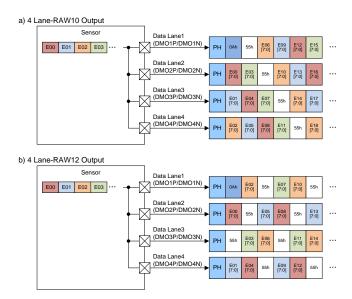
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Embedded Data Line (CSI-2)

The Embedded data line is output in a line following the sync code FS. In RAW10 mode, 55h dummy bytes are inserted after outputting 4 bytes of data each. In RAW12 mode, 55h dummy bytes are inserted after outputting 2 bytes of data each.



The each format of 4 Lane is shown below.



Output Format of Embedded 4 Lane (CSI-2)

Specific Output (CSI-2)

Output timing	bit	Transfer data	Description		
E00 to E05	[7:0]		(Ignored)		
E06	[0]	SMD			
E00	[7:1]		(Ignored)		
E07	[7:0]	PGC			
E08	[2:0]	FGC			
E00	[7:3]		(Ignored)		
E09	[7:0]	SHR			
E10	[7:0]	SHK			
E11	[7:0]	SVR			
E12	[7:0]	SVK			
E13 to E14	[7:0]		(Ignored)		
	[3:0]	DGAIN			
E15	[4]	MDVREV			
	[7:5]	_	(Ignored)		

Output timing	bit	Transfer data	Description
E16	[7:0]	BLKLEVEL	
E17 to E24	[7:0]	_	(Ignored)
E25	[0]	HTRIMMING_EN	
E23	[7:1]		(Ignored)
E26	[7:0]	HTRIMMING_START	
E27	[4:0]	TTRIMMING_START	
E21	[7:5]		(Ignored)
E28	[7:0]	HTRIMMING_END	
E29	[4:0]	TTKIWIWING_END	
L29	[7:5]		(Ignored)
E30	[0]	VWIDCUTEN	
L30	[7:1]		(Ignored)
E31	[7:0]	VWINPOS	
E32	[3:0]	VVIINFOS	
L32	[7:4]		(Ignored)
E33	[7:0]	VWIDCUT	
E34	[2:0]	VVIDCOI	
L34	[7:3]	_	(Ignored)
E35 to E139	[7:0]	_	(Ignored)

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CSI-2 serial Output Setting (CSI-2)

The output formats of this sensor support the following modes.

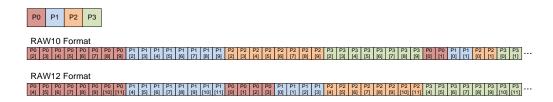
CSI-2 serial data output 4 Lane, RAW10 and RAW12

The image data is output from the CSI-2 output pin. The DMO1P/DMO1N are called the Lane1 data signal, the DMO2P/DMO2N are called the Lane2 data signal, the DMO3P/DMO3N are called the Lane3 data signal and the DMO4P/DMO4N are called the Lane4 data signal. In addition, the clock signals are output from DMCKP/DMCKN of the CSI-2 pins.

In 4 Lane mode, data is output from Lane1, Lane2, Lane3 and Lane4.

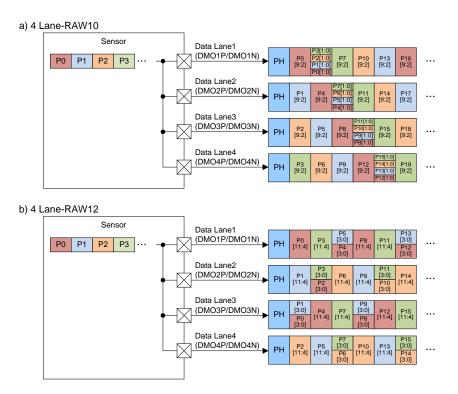
The bit rate maximum value is 1.440 Gbps/Lane.

The formats of RAW10 and RAW12 are shown below.



Example of formats of RAW10 and RAW12

The each format of 4 Lane are shown below.

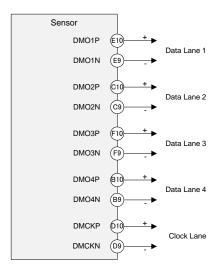


Output Format of 4 Lane (CSI-2)

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MIPI Transmitter (CSI-2)

Output pins (DMO1P to DMO4P, DMO1N to DMO4N, DMCKP, DMCKN) are described in this section.

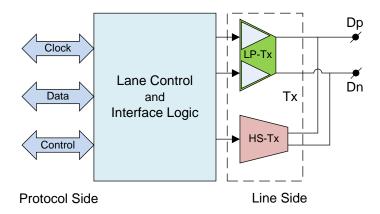


Relationship between Pin Name and MIPI Output Lane

The pixel signals are output by the CSI-2 High-speed serial interface. See the MIPI Standard

- MIPI Alliance Standard for Camera Serial Interface 2 (CSI-2) Version 1.1
- MIPI Alliance Specification for D-PHY Version 1.1

The CSI-2 transfers one bit with a pair of differential signals. The transmitter outputs differential current signal after converting pixel signals to it. Insert external resistance in differential pair in a series or use cells with a built-in resistance on the Receiver side. When inserting an external resistor, as close as possible to the Receiver. The differential signals maintain a constant interval and reach the receiver with the shortest wiring length possible to avoid malfunction. The maximum bit rate of each Lane are 1.440Gbps/Lane.



Universal Lane Module Functions

Detailed Specification of Each Mode (CSI-2)

1. Horizontal/Vertical Operation Period in Each Readout Drive Mode (CSI-2)

Horizontal Operation Period in Each Readout Drive Mode (CSI-2)

		Horizontal operation period (Number of pixels conversion)								
Readout	Front	Front ignored	Front effective	Recommended	Rear effective	Rear ignored	register			
mode No.	ignored	area of	margin for color	recording	margin for color	area of	minimum			
	area	effective pixel	processing	pixels	processing	effective pixel	value			
0	0	0	12	3072	12	0	493			
1	0	0	12	3072	12	0	263			
2	0	0	12	2592	12	0	493			
3	0	0	12	2592	12	0	263			
4	0	0	12	3072	12	0	493			
5	0	0	12	3072	12	0	263			
6	0	0	12	2160	12	0	493			
7	0	0	12	2160	12	0	263			

Vertical Operation Period in Each Readout Drive Mode (CSI-2)

Readout		Min	VMAX register					
mode No.	de No. Front Front igno		Front ignore area of margin for color ffective pixel processing recommende margin for color pixels Rear effective margin for color processing effective pixel		VBLK *1	minimu m value		
0	16	6	18	2160	18	0	13	4451
1	8	6	4	2160	4	0	13	4379
2	16	6	18	1944	18	0	13	4019
3	8	6	4	1944	4	0	13	3947
4	16	6	18	1728	18	0	13	3587
5	8	6	4	1728	4	0	13	3515
6	16	6	18	2160	18	0	13	4451
7	8	6	4	2160	4	0	13	4379

Unit: HMAX x72MHz clock. It includes FS and FE line. When VMAX is set to a nearby minimum value, set the value not to be less than the necessary VBLK value for DSP (Normally 10 to 20 lines is needed).

2. Frame Rate Adjustment (CSI-2)

The formula for frame rate calculation is shown below.

Frame rate [frame/s] = (72×10^6) / {HMAX register value × VMAX register value × (SVR register value + 1) }

The frame rate can be changed by changing HMAX and VMAX register values as long as these are set to minimum value or larger. HMAX changes the line blanking period. VMAX changes the frame blanking period.

The examples of setting for each readout drive mode are shown in the table below. Set HMAX and VMAX considering ISP image processing time.

The vertical sync signal XVS can be subsampled inside the sensor according to the SVR register. When using SVR = 1h, the frame rate becomes half. See "Electronic Shutter Timing" for details.

Examples of HMAX, VMAX and Frame Rate (CSI-2)

Readout	⊔N4∧∨*1	VMAX*2	Max frame		60 [fra	ame/s]			30 [fra	me/s]	
mode No.	min value	min value	frequency [frame/s]	HMAX ^{*1} [dec]	VMAX ^{*2} [dec]	SVR	Frame frequency [frame/s]	HMAX ^{*1} [dec]	VMAX ^{*2} [dec]	SVR	Frame frequency [frame/s]
0	493	4451	32.81	-	-	•	ı	500	4800	0	30.00
1	263	4379	62.52	269	4464	0	59.96 ^{*3}	500	4800	0	30.00
2	493	4019	36.34	-	-	•	ı	500	4800	0	30.00
3	263	3947	69.36	300	4000	0	60.00	500	4800	0	30.00
4	493	3587	40.71	-	-	•	ı	500	4800	0	30.00
5	263	3515	77.88	300	4000	0	60.00	500	4800	0	30.00
6	493	4451	32.81	-	-	-	1	500	4800	0	30.00
7	263	4379	62.52	269	4464	0	59.96 ^{*3}	500	4800	0	30.00

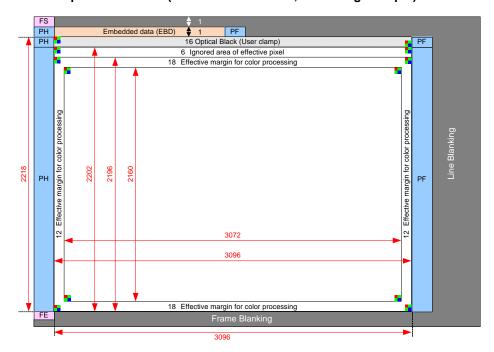
^{*1} The value set as HMAX (address 30F6h, bit [7:0] and address 30F7h, bit [7:0]).

The value set as VMAX (address 30F8h, bit [7:0], address 30F9h, bit [7:0] and address 30FAh, bit [3:0]).

^{*3} This frame rate is not compatible for 60.00 frame/s.

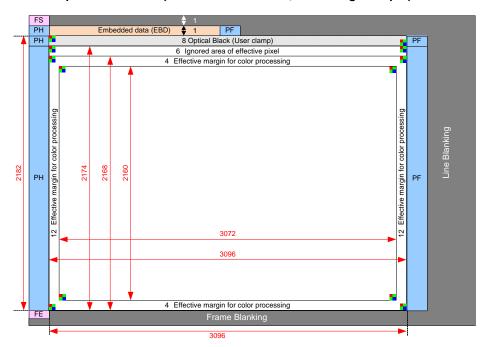
3. Image Data Output Format (CSI-2)

(CSI-2) MODE0: All-pixel scan mode (12-bit A/D conversion, 12-bit length output)



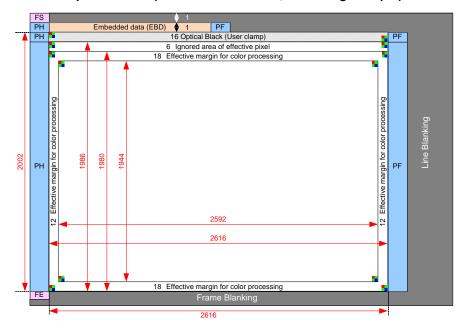
Readout Pixel Image Diagram (3072 x 2160)

(CSI-2) MODE1: All-pixel scan mode (10-bit A/D conversion, 10-bit length output)



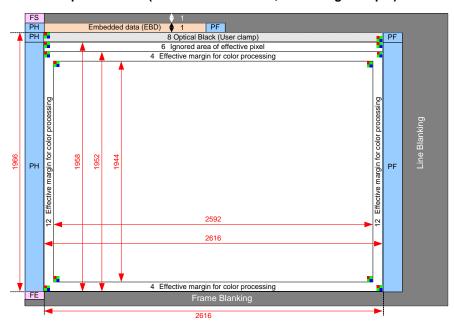
Readout Pixel Image Diagram (3072 x 2160)

(CSI-2) MODE2: 4:3 crop scan mode (12-bit A/D conversion, 12-bit length output)



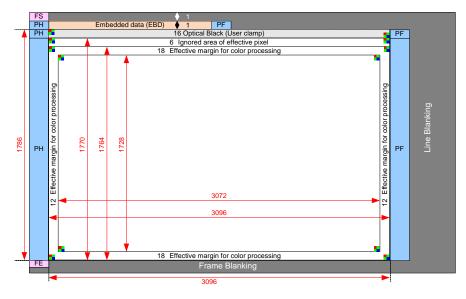
Readout Pixel Image Diagram (2592 x 1944)

(CSI-2) MODE3: 4:3 crop scan mode (10-bit A/D conversion, 10-bit length output)



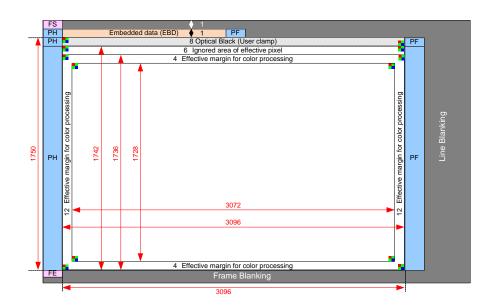
Readout Pixel Image Diagram (2592 x 1944)

(CSI-2) MODE4: 16:9 crop scan mode (12-bit A/D conversion, 12-bit length output)



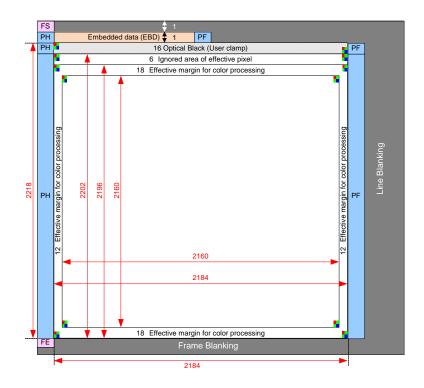
Readout Pixel Image Diagram (3072 x 1728)

(CSI-2) MODE5: 16:9 crop scan mode (10-bit A/D conversion, 10-bit length output)



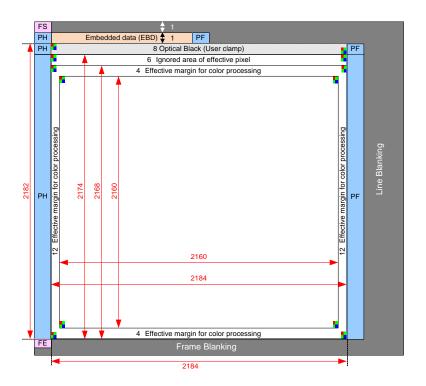
Readout Pixel Image Diagram (3072 x 1728)

(CSI-2) MODE6: 1:1 crop scan mode (12-bit A/D conversion, 12-bit length output)



Readout Pixel Image Diagram (2160 x 2160)

(CSI-2) MODE7: 1:1 crop scan mode (10-bit A/D conversion, 10-bit length output)



Readout Pixel Image Diagram (2160 x 2160)

Electronic Shutter Timing When Using CSI-2

1. SHR, SVR, SMD Setting When Using CSI-2

1-1. SHR, SVR Setting (CSI-2)

The exposure start timing can be designated by setting the electronic shutter timing register SHR. Note that this setting value unit is 1[HMAX]^{*1} period regardless of the readout drive mode. In addition, 1 frame period can be extended at VMAX period unit according to the SVR register. (1 frame cycle is (SVR value + 1) times as long as VMAX period.)

Shutter Control Register (CSI-2)

Name	CSI-2 Address	Bit	Function
SHR [7:0]	300Ch	[7:0]	Charifica the integration start harizontal period
SHR [15:8]	300Dh	[7:0]	Specifies the integration start horizontal period
SVR [7:0]	300Eh	[7:0]	Charifica the integration abutdown vertical period
SVR [15:8]	300Fh	[7:0]	Specifies the integration shutdown vertical period
HMAX [7:0]	30F6h	[7:0]	Harizantal drive pariod langth
HMAX [15:8]	30F7h	[7:0]	Horizontal drive period length
VMAX [7:0]	30F8h	[7:0]	
VMAX [15:8] 30F9h [7		[7:0]	Vertical drive period length
VMAX [19:16]	30FAh	[3:0]	

Shutter Setting (CSI-2)

Register		Function	
SHR	12 to {(SVR value + 1) × VMAX value - 4} 0 to {(SVR value + 1) × VMAX value - 130} 0 to {(SVR value + 1) × VMAX value - 130}	Readout mode No.0, 1, 2, 3, 4, 5, 6, 7 All-pixel scan mode (12 bits) All-pixel scan mode (10 bits) 4:3 crop scan mode (12-bit) 4:3 crop scan mode (10-bit) 16:9 crop scan mode (12-bit) 16:9 crop scan mode (10-bit) 1:1 crop scan mode (12-bit) 1:1 crop scan mode (10-bit) Global reset shutter mode (SMD = 1) (12 bits) Global reset shutter mode (SMD = 1) (10 bits)	Specifies the integration start horizontal period
SVR	0h to FFFFh *Note 2.		Specifies the integration shutdown vertical period

Note)

- See "Integration Time in Each Readout Drive Mode" on page 70 for the integration time calculation formula
- The SVR register definition areas are guaranteed as sensor functions, but the characteristics are not guaranteed.
- 3. SMD is the electronic shutter drive mode register (address 3008h, bit [0]).

^{*1} Setting value of register HMAX × 72MHz clock

1-2. Electronic Shutter Drive Mode (CSI-2)

Global reset shutter operation can be performed by setting the electronic shutter drive mode register SMD. Rolling shutter operation performs pixel reset and integration sequentially in line units. Global reset shutter operation resets all pixels at once and then starts integration after that.

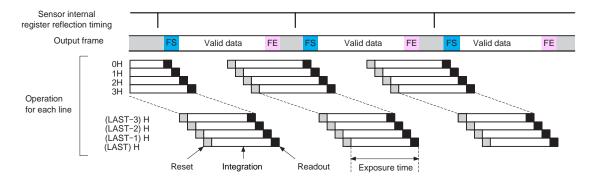
("Integration" is the state of a pixel between the reset and the readout. Pixels accumulate all the power of input light.) The mechanical shutter must also be used during global reset shutter operation to make the exposure time the same for all pixels.

Using XVS output sync signal from sensor as trigger signal is recommended in the case of synchronizing global reset shutter timing of sensor and mechanical shutter timing outside of sensor is needed for fine adjustment of integration time.

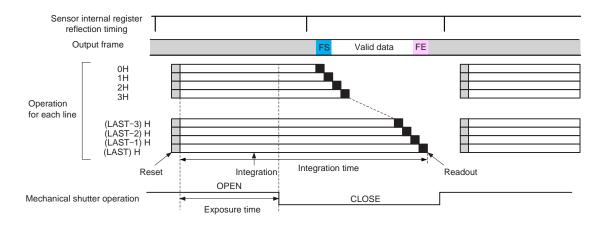
Consult your Sony sales representative concerning to use XVS output signal.

SMD Setting

Name	CSI-2 Address	Bit	Register value	Function
SMD	CMD 2000h		0h	Rolling shutter (normal shutter mode)
SIVID	3008h	[0]	1h	Global reset shutter



Rolling Shutter Operation



Global Reset Shutter Operation

IMX326LQC-C SONY

2. Integration Time in Each Readout Drive Mode and Mode Changes When Using CSI-2

2-1. Integration Time in Each Readout Drive Mode (CSI-2)

The integration time for this sensor's output data is set using the electronic shutter timing setting registers SHR and SVR. The formulas and constants used to calculate the integration time are shown below. In addition, the frame rate can be reduced by setting the SVR register to "1" or more.

◆ Integration time of normal readout drive mode

Integration Time $[s] = [\{VMAX \text{ value} \times (SVR \text{ value} + 1) - SHR \text{ value}\}$ × HMAX value + Number of clocks per internal offset period] / (72 x 10⁶)

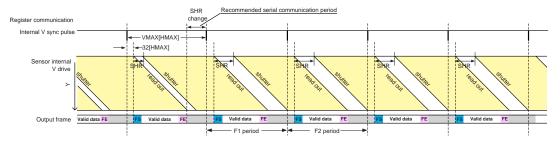
- * See the following tables for the numbers of clocks per internal offset period.
- * See "Electronic Shutter Timing" on page 68 of the SHR register setting range.

Number of clocks per internal offset period

Readout mode No.	0	1	2	3	4	5	6	7
Number of clocks per internal offset period	169	112	169	112	169	112	169	112

The figure below shows operation when SHR is being changed and REGHOLD is 0h. The F1 and F2 periods in the figure below are two continuous frames. The SHR value which is set in the recommended serial communication period 1 just before F1 period is updated internally at the end of the communication period and then output data which reflect the new setting is output in the F2 period. Note that the SHR setting and output are offset by a frame.

¹ Refer to "Register Communication Timing".

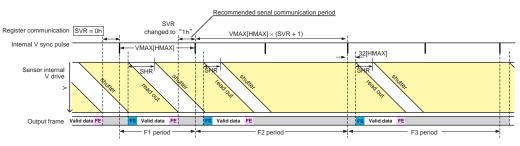


SHR Change Sequence (CSI-2)

The internal vertical drive period which is set by the VMAX register can be subsampled by the SVR register. Its period is (SVR value + 1) times as long as VMAX period. Therefore the frame rate is multiplied by 1/ (SVR value + 1). The figure below shows the operation when the SVR register is being changed from "0h" to "1h" and REGHOLD is 0h. The SVR value, which is set in the recommended serial communication period *1 just before F2 period, is updated internally at the end of the communication period and then applied from the shutter operation in the F2 period. The output data which reflect the changing of SVR is output in the F3 period.

The image data of the F1 period before the SVR value is changed is output as valid data in the F2 period.

^{*1} Refer to "Register Communication Timing".



SVR Change Sequence (CSI-2)

2-2. Operation when Changing the Readout Drive Mode (CSI-2)

When changing input INCK or CSI-2 output frequency, follow the below procedure.

1st step: Enter the sensor standby mode

2nd step: Change the frequency during standby mode.

3rd step: Follow the standby cancel sequence to resume the normal operation.

When changing input INCK frequency, don't input pulses whose width are shorter than the High / Low level width in front and behind of the INCK pulse at the frequency change. If the pulses above generate at the frequency change, change INCK frequency during system reset in the state of XCLR = Low. Then set the state of XCLR to High, following the item of "Power on sequence" in the section of "Power on / off sequence" in page 93. Execute "Standby Cancel Sequence" again because the register settings become default state after system reset.

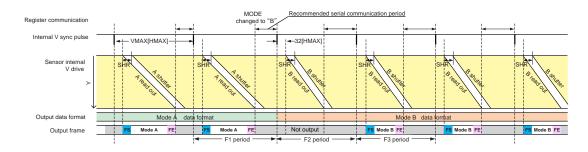
The following mode change cases are treated as a mode transition on this sensor and one frame of invalid data is generated.

- 1. Changing the readout mode setting
- 2. Changing the vertical direction readout setting

The figure below shows the mode transition sequence, Mode A to Mode B, in case that the mode transition is performed in three continuous frames, F1 to F3, and REGHOLD is 0h.

- (1) Set the register setting for Mode B in the recommended serial communication period ^{*1} just before F2 period. The F2 period data is not output.
- (2) Valid data which reflect the new setting is output from the next frame (F3 period).

In addition, note that when the output data length differs between Mode A and Mode B, the new data format is output from the start of F2 period in which the setting is changed to Mode B.



Mode Transition (CSI-2)

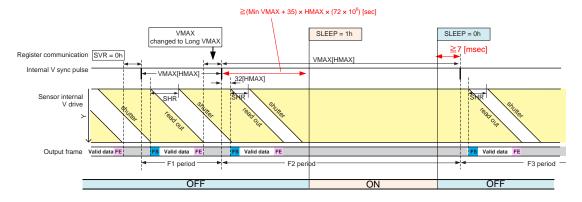
^{*1} Refer to "Register Communication Timing"

2-3. Low Power Consumption Drive in Integration Time When Using Rolling Shutter Operation (CSI-2)

To extend the integration time, VMAX register is available other than SVR register. VMAX register extends V period. SLEEP register can reduce power consumption during integration time when using large VMAX. To change to low power consumption drive, set SLEEP register to 1h after (VMAX value + 35) \times HMAX value \times (72 \times 10⁶) [sec] or more in the frame of changing the register SMD from 0h to 1h.

And for readout, set SLEEP to 0h before 7 ms of readout frame in order to cancel low power consumption mode.

When using $SVR \ge 1h$, this sequence is not necessary.



Low Power Consumption Drive in Integration Time When Using Rolling Shutter Operation (CSI-2)

Image Data Output Format When Using Sub-LVDS

1. Sync Signals and Data Output Timing (Sub-LVDS)

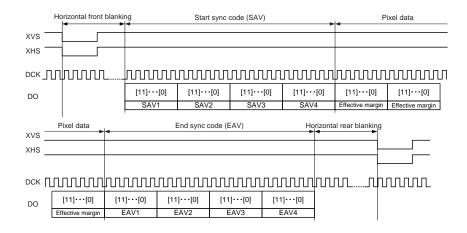
The figure below shows the sync signal and data output timing during 12-bit length serial output for this sensor.

The horizontal and vertical timing of the output data are controlled by the XVS and XHS sync signals. Timing control is performed at the falling edge of both the XVS and XHS signals. The data is output in order from the start sync code (SAV) after the horizontal front blanking period after the falling edge.

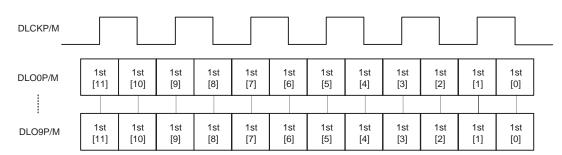
See "Horizontal/Vertical Operation Period in Each Readout Drive Mode" on pages 76 for the detailed blanking length and number of OB pixels. The length of horizontal front blanking pixels varies greatly according to the mode as described in "Horizontal/Vertical Operation Period in Each Readout Drive Mode" on page 76, so using the sync code as the trigger is recommended for the recording pixel start timing.

The sync code details are shown below.

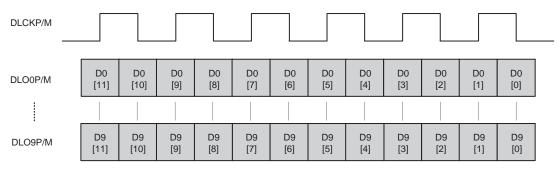
In addition, the length of horizontal rear blanking changes when the XHS period is changed.



Sync Signal and Data Output Timing



Serial Data Details (Sync Code Block)



Serial Data Details (Pixel Data Block)

IMX326LQC-C

Sync code details

SONY

LVDS out	put bit No.		Sync code	(4 words)		
12-bit output	10-bit output	1st word	2nd word	3rd word	4th word	
11	9	1	0	0	1	
10	8	1	0	0	0	
9	7	1	0	0	V	1: Blanking line 0: Except blanking line
8	6	1	0	0	Н	1: End sync code 0: Start sync code
7	5	1	0	0	P3	
6	4	1	0	0	P2	Protection bits
5	3	1	0	0	P1	Protection bits
4	2	1	0	0	P0	
3	1	1	0	0	0	
2	0	1	0	0	0	
1	_	1	0	0	0	
0	_	1	0	0	0	

			Protect	ion bits	
V	Н	P3	P2	P1	P0
0	0	0	0	0	0
0	1	1	1	0	1
1	0	1	0	1	1
1	1	0	1	1	0

Sync code details (hexadecimal notation) 12-bit output

		1st word	2nd word	3rd word	4th word
Dianking line	Start sync code (SAV)				AB0h
Blanking line	End sync code (EAV)] FFFh	0006	0006	B60h
Eveent blenking line	Start sync code (SAV)]	000h	000h	800h
Except blanking line	End sync code (EAV)				9D0h

Sync code details (hexadecimal notation) 10-bit output

		1st word	2nd word	3rd word	4th word
Planking line	Start sync code (SAV)				2ACh
Blanking line	End sync code (EAV)	3FFh	000h	0006	2D8h
Event blanking line	Start sync code (SAV)	SEE	00011	000h	200h
Except blanking line	End sync code (EAV)				274h

SONY IMX326LQC-C

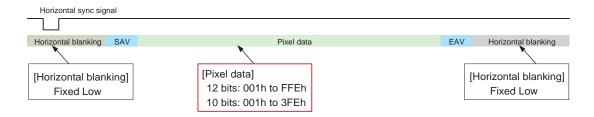
2. Output Range of LVDS Output Data (Sub-LVDS)

The table below shows the decimal point position, output bit length and output range of the output data in each readout mode. Note that the value of the first word of the sync code (3FFh, FFFh) and the maximum data value do not overlap in any readout mode.

Data output range in each readout mode

Readout	LVDS output						
mode No.	Decimal point position	Output bit length [bit]	Output range [hex]				
0, 2, 4, 6	2	12	001h to FFEh				
1, 3, 5, 7	0	10	001h to 3FEh				

Output value during horizontal blanking period is fixed to Low (all 0).



Readout Drive Timing

Detailed Specification of Each Mode (Sub-LVDS)

1. Horizontal/Vertical Operation Period in Each Readout Drive Mode (Sub-LVDS)

Horizontal Operation Period in Each Readout Drive Mode (Sub-LVDS)

			Horizo	ntal opera	ation period	(Number of pixe	els conversi	on)	
Readout		Horizontal		Front	Front		Rear	Rear	XHS
mode	Data rate	blanking		ignored	effective	Recommended	effective	ignored	minimum
No.	[MHz]	period	Front OB	area of	margin for	recording	margin for	area of	period
140.		[DCK]*2*3		effective	color	pixels	color	effective	[INCK]*2*4
				pixel	processing		processing	pixel	
0		399 to 405	0	0	12	3072	12	0	493
1		374 to 380	0	0	12	3072	12	0	260
2		399 to 405	0	0	12	2592	12	0	493
3	576	374 to 380	0	0	12	2592	12	0	260
4	(288DDR ^{*1})	399 to 405	0	0	12	3072	12	0	493
5		374 to 380	0	0	12	3072	12	0	260
6		399 to 405	0	0	12	2160	12	0	493
7		374 to 380	0	0	12	2160	12	0	260

^{*1} DDR: Double Data Rate

Vertical Operation Period in Each Readout Drive Mode (Sub-LVDS)

Readout	Number of lines per vertical operation period (output data 1H conversion)							
Readout mode No.		Front OB (User Clamp)	Front ignore area of effective pixel	margin for color	Recommended recording pixels	Rear effective	Rear ignored area of effective pixel	XVS minimum period [XHS]
0	26	16	6	18	2160	18	0	4462
1	26	16	6	18	2160	18	0	4462
2	26	16	6	18	1944	18	0	4030
3	26	16	6	18	1944	18	0	4030
4	26	16	6	18	1728	18	0	3598
5	26	16	6	18	1728	18	0	3598
6	26	16	6	18	2160	18	0	4462
7	26	16	6	18	2160	18	0	4462

^{*2} If XHS period is shorter than the (XHS minimum period + horizontal front blanking), the data from the previous line may be output during the horizontal front blanking period.

^{*3} Number of LVDS output signal DCK clock

^{*4} Number of clocks in conversion of INCK = 72 MHz.

2. Frame Rate Adjustment (Sub-LVDS)

The formula for frame rate calculation is shown below.

Frame rate [frame/s] = $(72 \times 10^6) / \{ XHS \text{ period [INCK]} \times XVS \text{ period [XHS]} \times (SVR \text{ register value} + 1) \}$

The frame rate can be changed by changing XHS period and XVS period as long as these are set to minimum value or larger. Larger XHS period results in longer horizontal blanking period. Larger XVS period results in longer vertical blanking period. The examples of setting for each readout drive mode are shown in the table below. Set XHS period and XVS period considering ISP image processing time.

The vertical sync signal XVS can be subsampled inside the sensor according to the SVR register. When using SVR = 1h, the frame rate becomes half. See "Electronic Shutter Timing" for details.

H Period and Number of XHS Pulses, V Period and XVS Pulses (Sub-LVDS)

Readout mode No.	H period (number of XHS pulses) *1	V period (number of XVS pulses) *2
0	2	1
1	2	1
2	2	1
3	2	1
4	2	1
5	2	1
6	2	1
7	2	1

Number of XHS pulses required to output the data for one line

Examples of HMAX, VMAX and Frame Rate (Sub-LVDS)

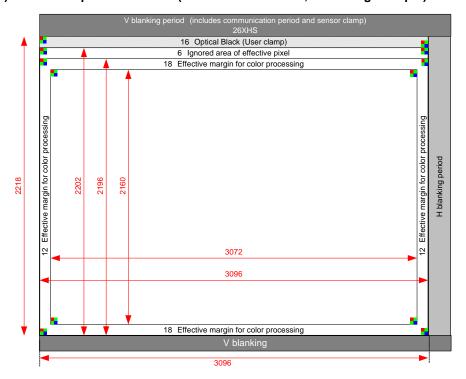
	XHS	XVS min			60 [fran	ne/s]			30 [frar	ne/s]	
Readout	min	_	Max frame		XVS				XVS		
mode	period	(number	frequency	XHS	period		Frame	XHS	period		Frame
No.	(INCK)	of XHS	[frame/s]	period	(number	SVR	frequency		(number	SVR	frequency
140.	*1	pulses)	[IIaiio/3]	(INCK)*1	of XHS		[frame/s]	(INCK) 1	of XHS		[frame/s]
		puiscoj			pulses)				pulses)		
0	493	4462	32.73	-	-	-	-	500	4800	0	30.00
1	260	4462	62.06	269	4464	0	59.96	500	4800	0	30.00
2	493	4030	36.24	-	-	-	-	500	4800	0	30.00
3	260	4030	68.72	269	4464	0	59.96	500	4800	0	30.00
4	493	3598	40.59	1	1	•	-	500	4800	0	30.00
5	260	3598	76.97	320	3750	0	60.00	500	4800	0	30.00
6	493	4462	32.73	-	-	-	-	500	4800	0	30.00
7	260	4462	62.06	269	4464	0	59.96	500	4800	0	30.00

^{*1} Number of clocks in conversion of INCK = 72 MHz

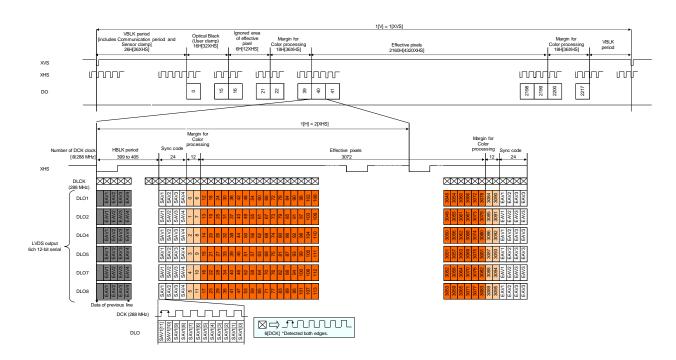
Number of XVS pulses required to output the data for one frame

3. Image Data Output Format (Sub-LVDS)

(Sub-LVDS) MODE0: All-pixel scan mode (12-bit A/D conversion, 12-bit length output)

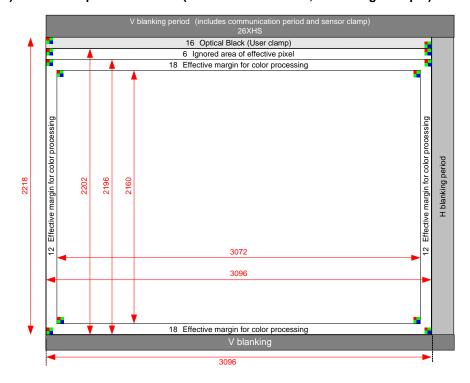


Readout Pixel Image Diagram (3072 x 2160)

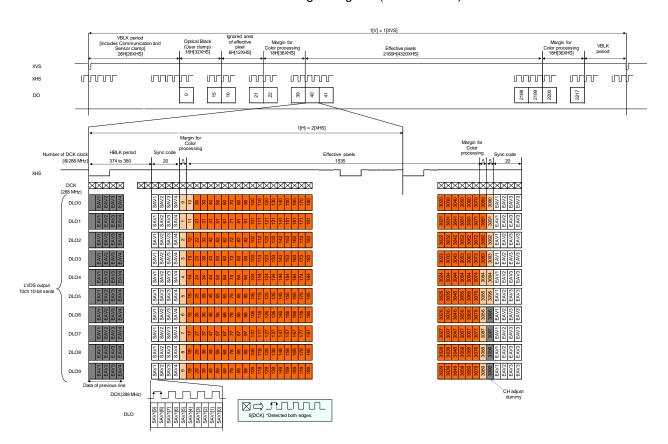


Readout Drive Timing

(Sub-LVDS) MODE1: All-pixel scan mode (10-bit A/D conversion, 10-bit length output)

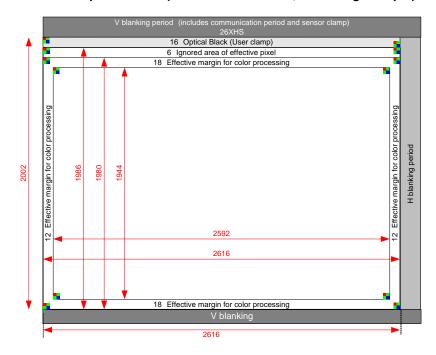


Readout Pixel Image Diagram (3072 x 2160)

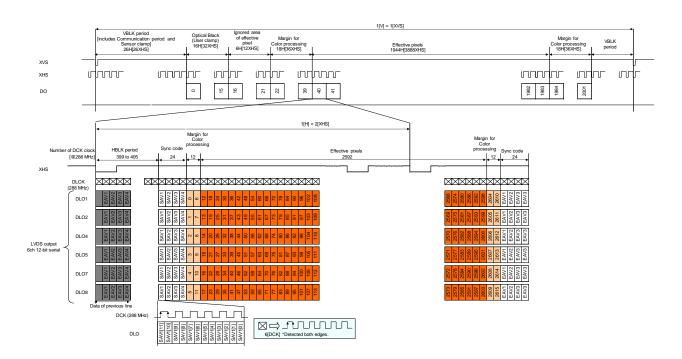


Readout Drive Timing

(Sub-LVDS) MODE2: 4:3 crop scan mode (12-bit A/D conversion, 12-bit length output)

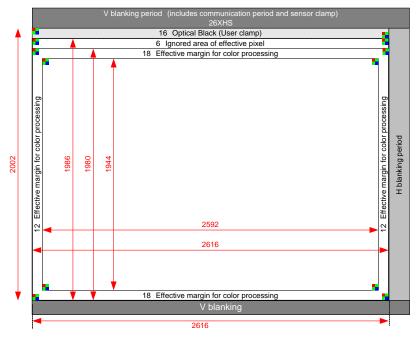


Readout Pixel Image Diagram (2592 x 1944)

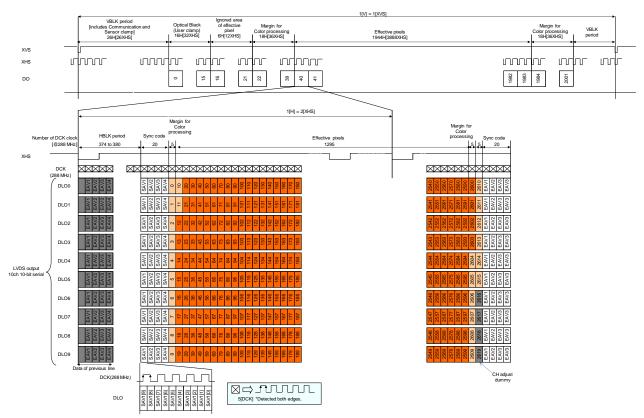


Readout Drive Timing

(Sub-LVDS) MODE3: 4:3 crop scan mode (10-bit A/D conversion, 10-bit length output)

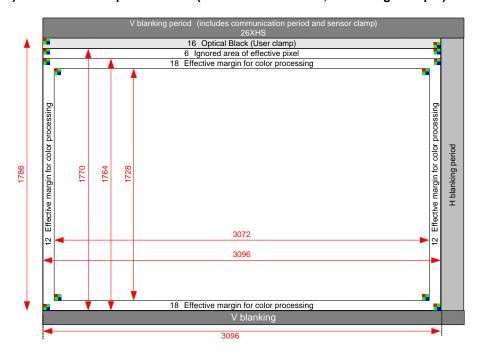


Readout Pixel Image Diagram (2592 x 1944)

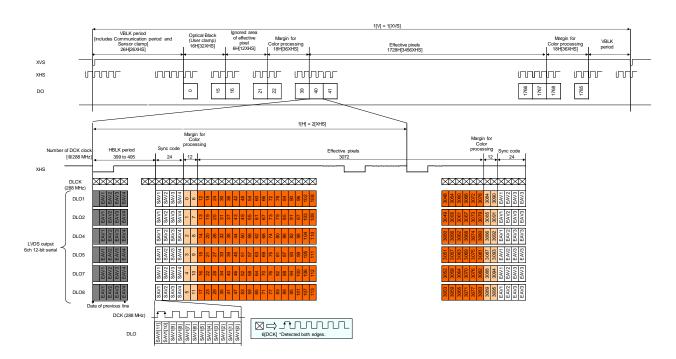


Readout Drive Timing

(Sub-LVDS) MODE4: 16:9 crop scan mode (12-bit A/D conversion, 12-bit length output)

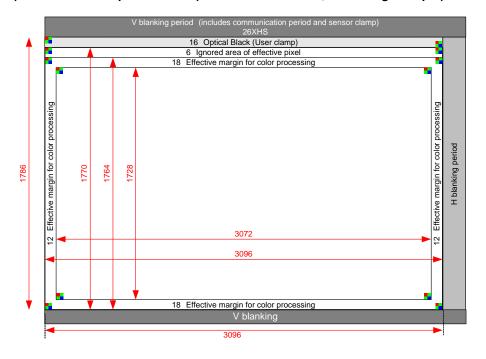


Readout Pixel Image Diagram (3072 x 1728)

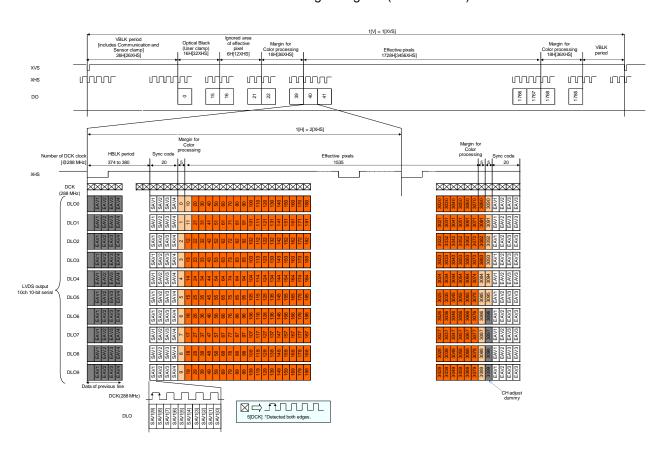


Readout Drive Timing

(Sub-LVDS) MODE5: 16:9 crop scan mode (10-bit A/D conversion, 10-bit length output)

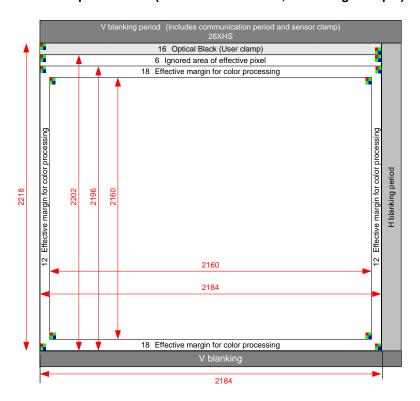


Readout Pixel Image Diagram (3072 x 1728)

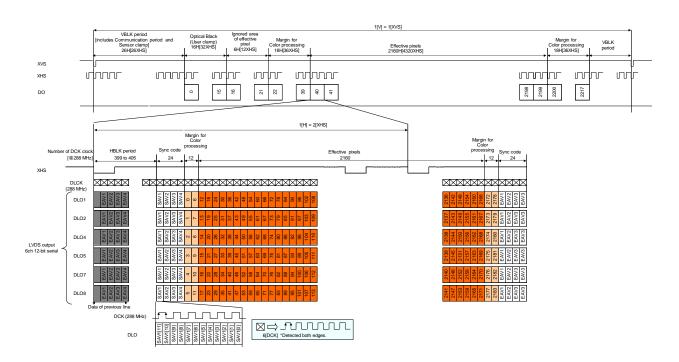


Readout Drive Timing

(Sub-LVDS) MODE6: 1:1 crop scan mode (12-bit A/D conversion, 12-bit length output)

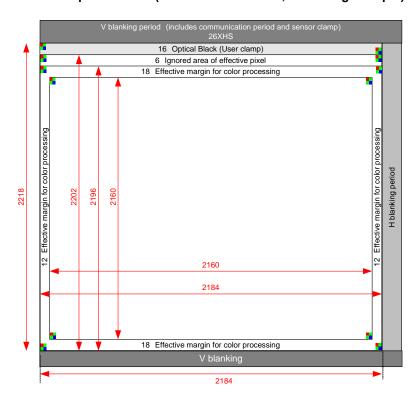


Readout Pixel Image Diagram (2160 x 2160)

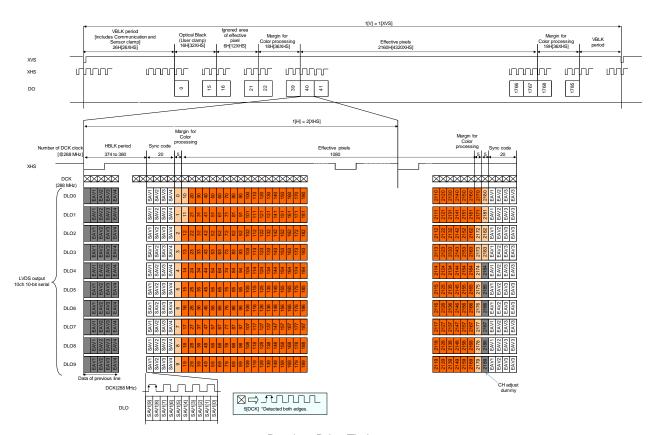


Readout Drive Timing

(Sub-LVDS) MODE7: 1:1 crop scan mode (10-bit A/D conversion, 10-bit length output)



Readout Pixel Image Diagram (2160 x 2160)



Readout Drive Timing

Electronic Shutter Timing When Using Sub-LVDS

1. SHR, SVR Setting (Sub-LVDS)

The exposure start timing can be designated by setting the electronic shutter timing register SHR. Note that this setting value unit is 1XHS*Note 1 period regardless of the readout drive mode. In addition, the vertical sync signal XVS can be subsampled inside the sensor according to the SVR register. The vertical sync signal period inside is (SVR value + 1) times as long as XVS signal period.

Shutter Setting (Sub-LVDS)

Name	Sub-LVDS Address	Bit	Function
SHR [7:0]	000Ch	[7:0]	Consider the interretion start having stall paried
SHR [15:8]	000Dh	[7:0]	Specifies the integration start horizontal period
SVR [7:0]	000Eh	[7:0]	Consider the interretion objet down continuous and
SVR [15:8]	000Fh	[7:0]	Specifies the integration shutdown vertical period

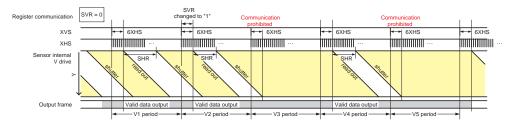
Register	Register Value		Function
SHR	12 to {(SVR value + 1) × Number of XHS pulses per frame - 4} 0 to {(SVR value + 1) × Number of XHS pulses per frame - 130} 0 to {(SVR value + 1) × Number of XHS pulses per frame - 130}	Readout mode No.0, 1, 2, 3, 4, 5, 6, 7 All-pixel scan mode (12 bits) All-pixel scan mode (10 bits) 4:3 crop scan mode (12-bit) 4:3 crop scan mode (10-bit) 16:9 crop scan mode (12-bit) 16:9 crop scan mode (10-bit) 1:1 crop scan mode (12-bit) 1:1 crop scan mode (10-bit) Global reset shutter mode (SMD = 1) *Note3 (12 bits) Global reset shutter mode (SMD = 1) (10 bits)	Specifies the integration start horizontal period
SVR	Oh to FFFFh *Note 2.		Specifies the integration shutdown vertical period

Note)

- 1. See "Integration Time in Each Readout Drive Mode" on page 88 for the integration time calculation formula.
- 2. The SVR register definition areas are guaranteed as sensor functions, but the characteristics are not guaranteed.
- 3. SMD is the electronic shutter drive mode register (address 0008h, bit [0]).

2. SVR Operation (Sub-LVDS)

Example of Electronic Shutter Operation when using Sub-LVDS is shown below.



Example of SVR operation

Note) In vertical sync signal subsampling periods (Example of SVR Operation: V3 and V5 periods), communication is prohibited during the normal communication period (the 6XHS period after the vertical sync signal XVS is input), except in the following case.

1. When stopping vertical sync signal subsampling using the break mode register SSBRK.

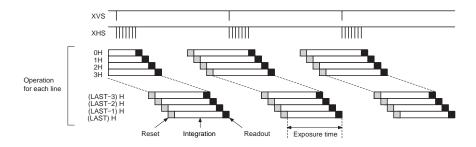
3. Electronic Shutter Drive Mode (Sub-LVDS)

Global reset shutter operation can be performed by setting the electronic shutter drive mode register SMD. Rolling shutter operation performs pixel reset and integration sequentially in line units in sync with the XHS signal. Global reset shutter operation resets all pixels at once and then starts integration after that.

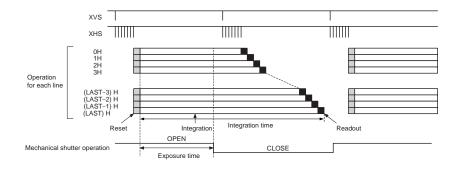
("Integration" is the state of a pixel between the reset and the readout. Pixels accumulate all the power of input light.) The mechanical shutter must also be used during global reset shutter operation to make the exposure time the same for all pixels.

SMD Setting

Name	CSI-2 Address	Bit	Register value	Function
SMD	0008h	[0]	0h	Rolling shutter (normal shutter mode)
SIVID	000611	[0]	1h	Global reset shutter



Rolling Shutter Operation



Global Reset Shutter Operation

4. Integration Time in Each Readout Drive Mode and Mode Changes When Using Sub-LVDS

4-1. Integration Time in Each Readout Drive Mode (Sub-LVDS)

The integration time for this sensor's output data is set using the electronic shutter timing setting registers SHR, SVR and SPL. The formulas and constants used to calculate the integration time are shown below. In addition, the frame rate can be reduced by setting the SVR register to "1" or more.

◆ Integration time of normal readout drive mode (Sub-LVDS)

Integration Time [s] = [{Number of XHS per XVS period × (SVR value + 1) – (SHR value)} × Number of clock per XHS Period + Number of clocks per internal offset period] / (INCK frequency [Hz] × INCK multiply rate)

- * Number of clock per XHS Period is in conversion of INCK = 72 MHz.
- * See the following tables for the numbers of clocks per internal offset period and INCK multiply rate.
- * See "Electronic Shutter Timing" on page 86 for the SHR register setting range.

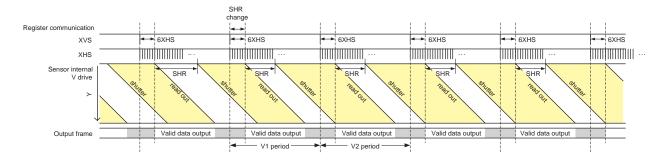
Number of clocks per internal offset period (Sub-LVDS)

Readout mode No.	0	1	2	3	4	5	6	7
Number of clocks per internal offset period	169	112	169	112	169	112	169	112

INCK multiply rate (Sub-LVDS)

INCK frequency setting [MHz]	72	36	24	12
INCK multiply rate	1	2	3	6

The figure below shows operation when changing SHR. The V1 and V2 periods in the figure below are two continuous XVS periods. The SHR value set within the first 6XHS periods (recommended serial communication period) of V1 is updated internally at the end of the 6XHS periods, and then output data which reflect the new setting is output in the V2 period. Note that the SHR setting and output are offset by 1XVS period.

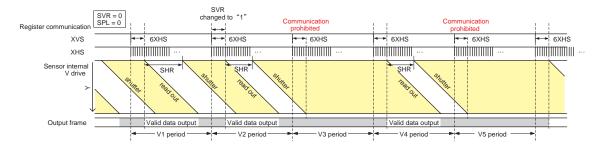


SHR Change Sequence (Sub-LVDS)

The vertical sync signal XVS can be subsampled inside the sensor according to the SVR register. The vertical sync signal period inside the sensor is (SVR value + 1) times as long as XVS signal period. Therefore the frame rate is multiplied by 1/(SVR value + 1) according to the SVR value.

The figure below shows the operation when changing the SVR register. The example in the figure below shows the update timing when SPL = 0 and the SVR value is changed from "0" to "1". The SVR value set within the first 6XHS periods (recommended serial communication period) of V2 is updated internally at the end of the 6XHS periods, and then applied from the shutter operation in the V2 period. Readout operation is not performed in the V3 period, and output data which reflect the changing of SVR is output in the V4 period.

The image data of the V1 period before the SVR value is changed is output as valid data in the V2 period. In addition, note that communication is also prohibited during the first 6XHS periods (recommended serial communication period) of the V3 period (the frame during which readout operation is not performed)



SVR Change Sequence (Sub-LVDS)

4-2. Operation when Changing the Readout Drive Mode (Sub-LVDS)

The following change cases are treated as mode transition on this sensor.

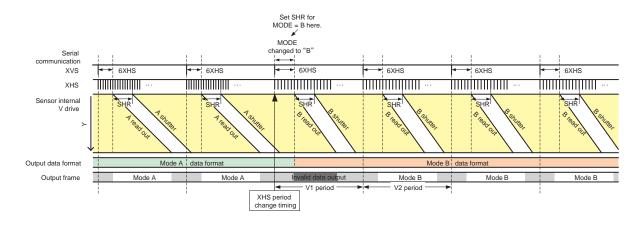
- 1. Changing the readout mode setting
- 2. Changing the vertical direction readout inversion setting

One frame of invalid data is always generated when changing the readout drive mode.

The figure below shows the mode transition sequence (Mode A to Mode B). The output data is invalid in the frame (V1 period in figure when SVR = 0) in which the setting is changed to Mode B. Valid data which reflect the new setting is output from the next frame (V2 period).

If the XHS period for Mode A and Mode B differs, change XHS period at the timing shown in the figure below (V1 head).

In addition, note that when the output data length or the output data rate differ in Mode A and Mode B, the new data format is output from the start of the 7th XHS of the frame (V1 period) in which the setting is changed to Mode B.



Mode Transition (Sub-LVDS)

4-3. Recommended Global Reset Shutter Operation Sequence (Sub-LVDS)

The recommended global reset shutter operation sequence is shown below. Operation in this mode spans plural XVS periods. Global reset shutter is performed in the first XVS period, and the data is output in following other XVS periods.

The exposure time can be adjusted by varying the XVS input period. However, the minimum XVS period is 14XHS periods. In addition, the mechanical shutter must also be used to make the exposure time the same for all pixels. See "Electronic Shutter Timing" on page 86 for the SHR register setting range.

Recommended Operating Sequence for Global Reset Shutter (Sub-LVDS)

Operation item	Description	Explanatory diagram
Normal	When performing global reset shutter partway through rolling shutter operation	Global reset shutter normal operation
Continuous	When performing global reset shutter operation continuously	Global reset shutter continuous operation

Normal Operation

Operation when performing global reset shutter + all-pixel scan (12 bits) one time partway through rolling shutter operation is shown below.

All-pixel scan (10bit) mode is described as a typical example of rolling shutter operation, but the transition operation is the same for all modes that use rolling shutter.

V1 to V3 in the figure below are three continuous XVS periods. When the global reset shutter settings (SMD = 1, register setting for all-pixel scan mode (12 bits)) are made within the first 6XHS periods (recommended serial communication period) of the V1 period, integration starts simultaneously for all pixels at the end of the 6XHS period. Global reset shutter readout data is output during the V2 period.

Communication to return to the original mode (SMD = 0, register setting for vertical subsampling mode, SHR should also be changed as necessary) is performed at the start of the V3 period.

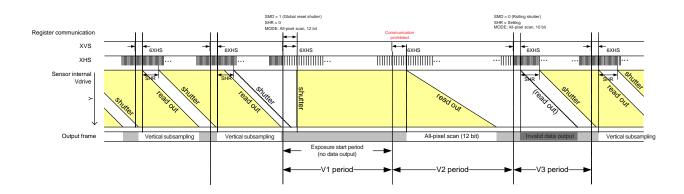
The output data for the frame immediately after that (the V3 period in the figure) is invalid.

Note that communication is also prohibited during the first 6XHS periods (recommended serial communication period) of the V2 period. The table below shows the integration start time of the exposure start period (V1 period).

Integration Start Time of the Exposure Start Period (Sub-LVDS)

Readout	Integration start time of the exposure start period
mode No.	(XVS reference)
0 ,2 ,4 ,6	Approx. 491 [INCK] after the (6 + SHR) XHS period ends *1
1 ,3 ,5 ,7	Approx. 258 [INCK] after the (6 + SHR) XHS period ends *1

Number of clocks in conversion of INCK = 72 MHz



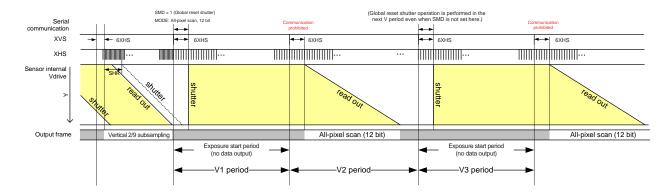
Global Reset Shutter Normal Operation (Sub-LVDS)



Continuous Operation (Sub-LVDS)

Operation when continuously performing global reset shutter + all-pixel scan (12 bits) is shown below. V1 to V3 in the figure below are three continuous XVS periods. When the global reset shutter + all-pixel scan (12 bits) settings (SMD = 1, register setting for all-pixel scan mode (12 bits)) are made within the first 6XHS periods (recommended serial communication period) of the V1 period, integration starts simultaneously for all pixels at the end of the first 6XHS period of the V1 period, and the all-pixel scan (12 bits) data is output in the V2 period. The operation during V1 and V2 periods is then repeated each time XVS is input until the mode setting is changed next. Note that communication is also prohibited during the first 6XHS periods (recommended serial communication period) in the V2 period.

See the previous section for a description of the procedure when changing from continuous operation to a different readout mode.

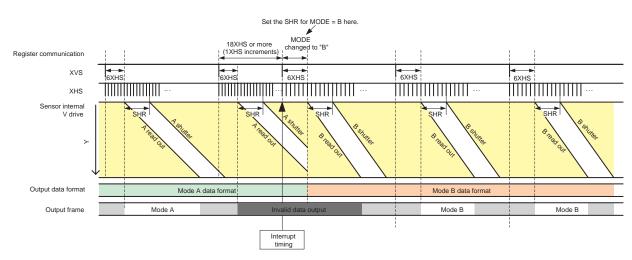


Global Reset Shutter Continuous Operation (Sub-LVDS)

4-4. Interruptive Mode Change (Sub-LVDS)

The sensor mode can be changed using interrupts in all modes.

When changing the mode using an interrupt, the mode can be changed by inputting XVS in sync with XHS after 18XHS periods or more have elapsed from the start of the frame, and transmitting the mode setting register value within the communication period. In addition, the data output before the interrupt mode change is cut off at the timing of the interrupt mode change.



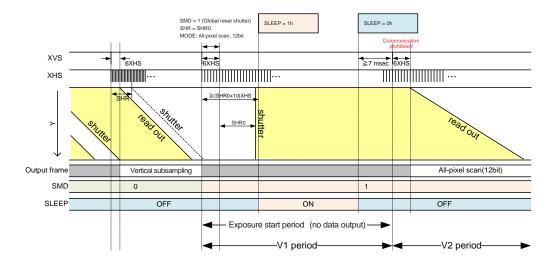
Interruptive Mode Change

4-5. Low Power Consumption Drive in Exposure Time (Sub-LVDS)

Low Power Consumption Drive in Exposure Time When Using Global Reset Shutter Operation (Sub-LVDS)

The sequence of low power consumption drive when exposing of global reset shutter operation is shown below. To change to low power consumption drive, set the SLEEP register to 1h after (SHR setting value + 10) \times XHS period or more in the frame of changing the register SMD from 0h to 1h.

And for readout, set SLEEP to 0h before 7 ms of readout frame in order to cancel low power consumption mode.

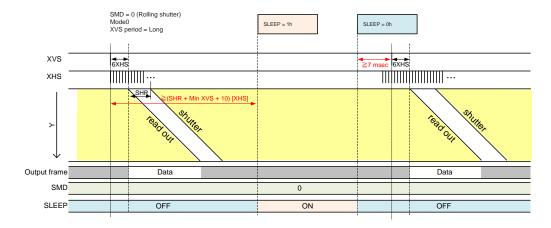


Low Power Consumption Drive in Exposure of Global Reset Shutter Operation Sequence (Sub-LVDS)

Low Power Consumption Drive in Integration Time When Using Rolling Shutter Operation (Sub-LVDS)

To extend the integration time, extending XVS period is available other than SVR register. SLEEP register can reduce power consumption during integration time when using long XVS period. To change to low power consumption drive, set SLEEP register to 1h after (SHR value + min XVS + 35) × XHS period or more in the frame of changing the register SMD from 0h to 1h. And for readout, set SLEEP to 0h before 7 ms of readout frame in order to cancel low power consumption mode.

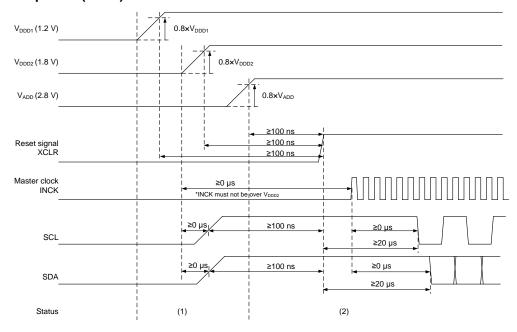
When using $SVR \ge 1h$, this sequence is not necessary.



Low Power Consumption Drive in Integration Time When Using Rolling Shutter Operation (Sub-LVDS)

Power-on/off Sequence when using CSI-2

1. Power-on Sequence (CSI-2)

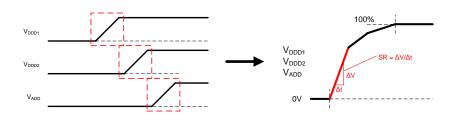


Power-on Sequence (CSI-2)

Period name	Remarks
(1) Power stabilization	All input signals are set to Low level.
period	There are no constraints of the power-on sequence with V_{ADD} , V_{DDD1} , and V_{DDD2} .
(2) Register communication period for standby cancel	Wait 100 ns after the last power supply in V_{ADD} , V_{DDD1} and V_{DDD2} . Then set XCLR to "H" and start the standby cancel sequence.

2. Slew Rate Limitation of Power-on Sequence (CSI-2)

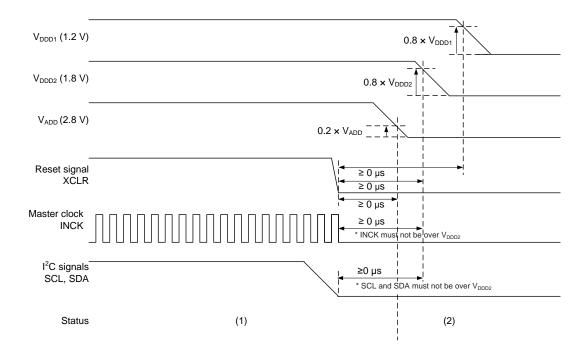
Conform to the slew rate limitation shown below when power supply change 0 V to each voltage (0 % to 100 %) in power-on sequence.



Item	Symbol	Power supply	Min.	Max.	Unit	Remarks
		V _{DDD1} (1.2 V)		25	mV/us	
Slew rate	SR	V _{DDD2} (1.8 V)		25	mV/us	
		V _{ADD} (2.8 V)		25	mV/us	

3. Power-off Sequence (CSI-2)

Make sure that all input signals are set to LOW level in the area of (2).



Power-off Sequence (CSI-2)

Period name	Remarks			
(1) Pixel output period	Pixel signal output period			
(2) Power-off period	Turn the power supplies off after all input signals are set to "Low" level except SCL and SDA. Set SCL and SDA to "Low" level at the same time with turning off the power supply of V_{DDD2} . There are no constraints of the power-off sequence with V_{ADD} , V_{DDD1} , and V_{DDD2} .			

Standby Cancel Sequence when using CSI-2

After the power-on start-up sequence is performed, this sensor is in standby mode. The standby cancels sequence is described below. Also perform this same sequence when canceling standby mode after shifting from normal operation to standby mode.

- 1. After performing the power-on start-up sequence, make the following register setting.
 - Set address 3000h, bit [4:0] to "12h" (STANDBY register = 0h, STBLOGIC register = 1h, STBMIPI register = 0h, STBDV register = 1h).
 - Set the following registers to the appropriate value according to INCK's frequency.

Refer to "Description of Register" of "Register Map" on page 44.

Address 3120h, bit [7:0], Address 3121h, bit [7:0] (PLRD1 register).

Address 3122h, bit [7:0] (PLRD2 register).

Address 3129h, bit [7:0] (PLRD3 register).

Address 312Ah, bit [7:0] (PLRD4 register).

Address 312Dh, bit [7:0] (PLRD5 register).

Lastly, set address 310Bh, bit [7:0] to "00h" (STBPL_IF register = 0h, STBPL_AD register = 0h).

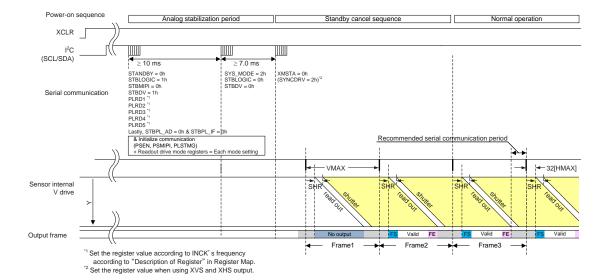
- Initialize communication
 - Set all registers of PSMOVEN, PSMIPI1 to 4 and PLSTMG settings.

See "Readout Drive Pulse Timing" on pages 47. Register communication can be performed even when STANDBY is 1h and there is no restriction on the communication order.

Set Readout drive mode registers

Set the mode registers of the "Register Setting for Each Readout Drive Mode" on page 51 to 52. Furthermore, set the required shutter and gain registers.

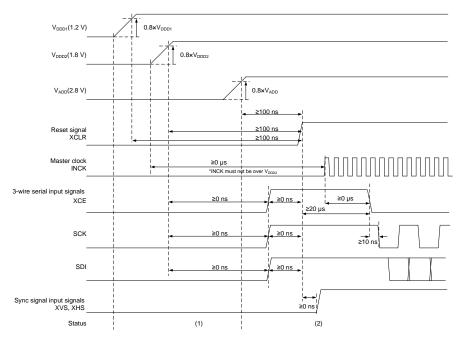
- 2. After the 1st stabilization period of 10 ms or more, make the following register setting.
 - Set address 3000h, bit [4:0] to "00h" (STANDBY register = 0h, STBLOGIC register = 0h, STBMIPI register = 0h, STBDV register = 0h).
 - Set address 303Eh, bit [1:0] to "02h" (SYS_MODE register = 2h)
- 3. After the 2nd stabilization period of 7.0ms or more,
 - Set address 30F4h, bit [0] to "0h" (XMSTA =0h).
 - Set address 3018h, bit [1:0] to "2h" (SYNCDRV =2h) (when using XHS and XVS output)



Power-on/off Sequence when using Sub-LVDS

1. Power-on Sequence (Sub-LVDS)

Make sure that both XVS and XHS must be set to LOW while XCLR is LOW.

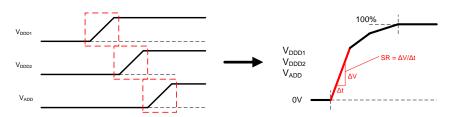


Power-on Sequence (Sub-LVDS)

Period name	Remarks			
(1) Power stabilization time	All input signals are LOW level.			
(1) Power stabilization time	There are no constraints of the power-on sequence with V _{ADD} , V _{DDD1} , and V _{DDD2} .			
(2) Standby cancel register communication	Wait 100 ns after the last power supply in V_{ADD} , V_{DDD1} and V_{DDD2} . Then set XCLR to "High" level and start the standby cancel sequence.			
Communication	XVS and XHS must be set to LOW while setting XCLR to LOW.			

2. Slew Rate Limitation of Power-on Sequence (Sub-LVDS)

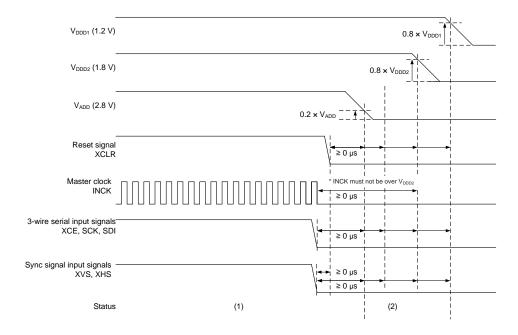
Conform the slew rate limitation shown below when power supply change 0 V to each voltage (0 % to 100 %) in power-on sequence.



Item	Symbol	Power supply	Min.	Max.	Unit	Remarks
		V _{DDD1} (1.2 V)	_	25	mV/μs	
Slew rate	SR	V _{DDD2} (1.8 V)	_	25	mV/μs	
		V _{ADD} (2.8 V)	-	25	mV/μs	

3. Power-off Sequence (Sub-LVDS)

Make sure that all input signals for the 3-wire serial interface and other signals are LOW in the period of (2) and both XVS and XHS must be set to LOW while setting XCLR to LOW.



Power-off Sequence (Sub-LVDS)

Period name	Remarks
(1) Pixel output period	Pixel signal output period
(2) Power-off time	Turn the power supplies off after LOW level is set to all input signals. There are no constraints of the power-off sequence with V_{ADD} , V_{DDD1} and V_{DDD2} .
(2) Fower-on time	XVS and XHS must be set to LOW while setting XCLR to LOW.

Standby Cancel Sequence (Sub-LVDS)

After the power-on start-up sequence is performed, this sensor is in standby mode. The standby cancel sequence is described below. Also perform this same sequence when canceling standby mode after shifting from normal operation to standby mode.

After performing the power-on start-up sequence, make the following register setting.

- 1. After performing the power-on start-up sequence, make the following register setting.
 - Set address 0000h, bit [4:0] to "1Ah" (STANDBY register = 0h, STBLOGIC register = 1h, STBMIPI register = 1h, STBDV register = 1h).
 - Set address 003Eh, bit [1:0] to "0h" (SYS_MODE register = 0h).
 - Set the following registers to the appropriate value according to INCK's frequency.

Refer to "Description of Register" of "Register Map" on page 44.

Address 0120h, bit [7:0], Address 0121h, bit [7:0] (PLRD1 register).

Address 0122h, bit [7:0] (PLRD2 register).

Address 0129h, bit [7:0] (PLRD3 register).

Address 012Ah, bit [7:0] (PLRD4 register).

Address 012Dh, bit [7:0] (PLRD5 register).

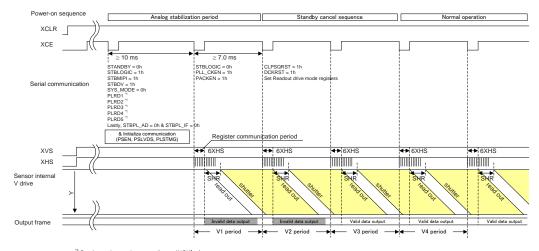
Lastly, set address 010Bh, bit [7:0] to "00h" (STBPL_AD register = 0h, STBPL_IF register = 0h).

- Initialize communication

Set all registers of PSMOVEN, PSLVDS1 to 4 and PLSTMG settings in "Readout Drive Pulse Timing" on pages 47. Register communication can be performed even when STANDBY is 1h and there is no restriction on the communication order. Vertical and horizontal sync signal, XVS and XHS, can be input during this communication.

- 2. After the 1st analog stabilization period of 10 ms or more,
 - Set address 00E6h, bit [7:0] to "01h" (PLL_CKEN register = 01h).
 - Set address 00E8h, bit [7:0] to "01h" (PACKEN register = 01h).
 - Set address 0000h, bit [4:0] to "18h" (STANDBY register = 0h, STBLOGIC register = 0h, STBMIPI register = 1h, STBDV register = 1h).
- 3. After the 2nd analog stabilization period of 7.0 ms or more, set the following registers during the register communication period of the next frame (the V2 period).
 - Set address 0001h, bit [4] to "1h" (CLPSQRST=1h) and set address 0009h, bit [0] to "1h" (DCKRST=1h)
 - Readout drive mode registers
 - Set the mode registers of the "Register Setting for Each Readout Drive Mode" on pages 53 to 54.
 - Furthermore, set the required shutter and gain registers.

In addition, when using the V3 period data after canceling standby mode, transmit the mode select register required for normal operation during the communication period of V2 period.



^{*1} Set the register value according to INCK's frequency according to "Description of Register" in Register Map

Spot Pixel Specifications

 $(V_{ADD}$ = 2.8 V, V_{DDD1} = 1.2 V, V_{DDD2} = 1.8 V, Tj = 60 °C, 29.97 frame/s, reference gain 0 dB)

Type of distortion	Level		n distorted pixels each zone	Measure- ment	Remarks
		0 1 11 11'	OB III	method	
Black pixels at high light	30 % ≤ D		No evaluation criteria applied	1	
White pixels at high light	30 % ≤ D	60	No evaluation criteria applied	1	
White pixels in the dark	5.6 mV ≤ D	640	No evaluati criteria appl	2	1/30 s integration
Black pixels at signal saturated	D ≤ 441mV	0	No evaluation criteria applied	3	

Note)

- 1. D...Spot pixel level. Black pixels at signal saturated are prescribed at the signal output in spot pixel part.
- 2. Zone definition is illustrated in the figure below.
- 3. 1 digit \approx 0.2068 mV when 12 bits output.

Spot Pixel Zone Definition

TBD

Notice on White Pixels Specifications

After delivery inspection of CMOS image sensors, cosmic radiation may distort pixels of CMOS image sensors, and then distorted pixels may cause white point effects in dark signals in picture images. (Such white point effects shall be hereinafter referred to as "White Pixels".) Unfortunately, it is not possible with current scientific technology for CMOS image sensors to prevent such White Pixels. It is recommended that when you use CMOS image sensors, you should consider taking measures against such White Pixels, such as adoption of automatic compensation systems for White Pixels in dark signals and establishment of quality assurance standards. Unless the Seller's liability for White Pixels is otherwise set forth in an agreement between you and the Seller, Sony Corporation or its distributors (hereinafter collectively referred to as the "Seller") will, at the Seller's expense, replace such CMOS image sensors, in the event the CMOS image sensors delivered by the Seller are found to be to the Seller's satisfaction, to have over the allowable range of White Pixels as set forth above under the heading "Spot Pixels Specifications", within the period of three months after the delivery date of such CMOS image sensors from the Seller to you; provided that the Seller disclaims and will not assume any liability after you have incorporated such CMOS image sensors into other products. Please be aware that Seller disclaims and will not assume any liability for (1) CMOS image sensors fabricated, altered or modified after delivery to you, (2) CMOS image sensors incorporated into other products, (3) CMOS image sensors shipped to a third party in any form whatsoever, or (4) CMOS image sensors delivered to you over three months ago. Except the above mentioned replacement by Seller, neither Sony Corporation nor its distributors will assume any liability for White Pixels. Please resolve any problem or trouble arising from or in connection with White Pixels at your costs and expenses.

[For Your Reference] The Annual Number of White Pixels Occurrence

The chart below shows the predictable data on the annual number of White Pixels occurrence in a single-story building in Tokyo at an altitude of 0 meters. It is recommended that you should consider taking measures against the annual White Pixels, such as adoption of automatic compensation systems appropriate for each annual number of White Pixels occurrence.

The data in the chart is based on records of past field tests, and signifies estimated number of White Pixels calculated according to structures and electrical properties of each device. Moreover, the data in the chart is for your reference purpose only, and is not to be used as part of any CMOS image sensor specifications.

Example of Annual Number of Occurrence

White Pixel Level (in case of storage time = $1/30 \text{ s}$) (Tj = $60 ^{\circ}\text{C}$)	Annual number of occurrence
5.6 mV or higher	11.0 pcs
10.0 mV or higher	6.0 pcs
24.0 mV or higher	3.0 pcs
50.0 mV or higher	1.0 pcs
72.0 mV or higher	1.0 pcs

Note 1) The above data indicates the number of White Pixels occurrence when a CMOS image sensor is left for a year.

Note 2) The annual number of White Pixels occurrence fluctuates depending on the CMOS image sensor storage environment (such as altitude, geomagnetic latitude and building structure), time (solar activity effects) and so on. Moreover, there may be statistic errors. Please take notice and understand that this is an example of test data with experiments that have being conducted over a specific time period and in a specific environment.

Note 3) This data does not guarantee the upper limits of the number of White Pixels occurrence.

For Your Reference:

The annual number of White Pixels occurrence at an altitude of 3,000 meters is from 5 to 10 times more than that at an altitude of 0 meters because of the density of the cosmic rays. In addition, in high latitude geographical areas such as London and New York, the density of cosmic rays increases due to a difference in the geomagnetic density, so the annual number of White Pixels occurrence in such areas approximately doubles when compared with that in Tokyo.

Material_No.03-0.0.8

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Measurement Method for Spot Pixels

1. Black or white pixels at high light

After adjusting the luminous intensity so that the average value of the G channel signal output is 255 digit when 10 bits output (1020 digit when 12 bits output), measure the local dip point (black pixel at high light, V_{BR} , V_{BG} and V_{BB}) and peak point (white pixel at high light, V_{KR} , V_{KG} and V_{KB}) in each channel signal output. Substitute the values into the following formula.

Spot pixel level = $(V_{Ki} \text{ (or) } V_{Bi})/V_i \times 100 \text{ [%] (i = R, G, B)}$ White pixel

Vi (i = R, G, B)

VG = 255 digit when 10 bits output)

OB output

OB output

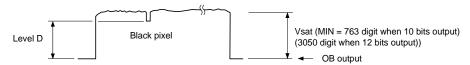
Signal output waveform of R/G/B channel (Black or White Pixels at High Light)

2. White pixels in the dark

Set the device to a dark setting and measure the local peak point of the signal output waveform using the average value of the dark signal output as a reference.

3. Black pixels at signal saturated

Set the device to operate in saturation and measure the local dip point in each of the R, G and B channels using the OB output with sensor as a reference.



Signal output waveform of R/G/B channel (Black Pixels at Signal Saturated)

Spot Pixel Pattern Specifications

The white pixel and the black pixel are counted as follows.

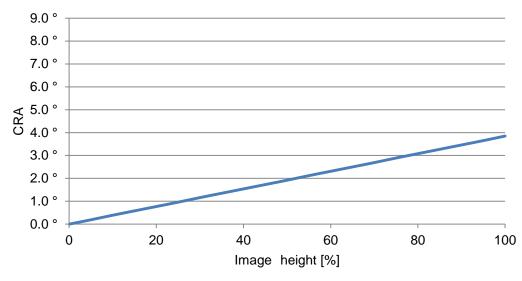
No.	Pattern R G G B	It provides by color filter array described in the left.	White pixels in the dark	Black pixels at high light	White pixels at high light
1		Same color	Rejected	Rejected	Rejected
2		Same color	Allowed	Allowed	Allowed
3		Different color	Allowed	Allowed	Allowed
4		Same color	Rejected	Rejected	Rejected
5		Different color	Allowed	Allowed	Allowed

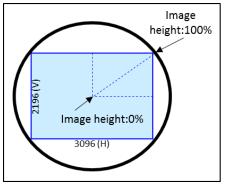
Note)

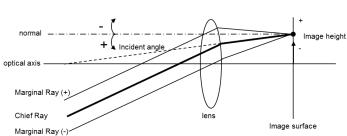
- It shows the position of black pixels and white pixels. Black pixels and white pixels are separately counted. (Example: Even if black pixel is adjacent to white pixel like No. 1, it is not counted as a pattern. They are not rejected.)
- 2. "Rejected" means that it is rejected as a sensor with one or more pieces of spot pixel to select.
- 3. "Allowed" means that it is not selected to be rejected. It is included in the number of allowable spot pixels by zone and is counted.
- 4. All spot pixels of the pattern other than the described above is included in the number allowable spot pixels by zone.

Relation between Image Height and target CRA

IMX326LQ 6.80M CRA.VS. Image height







SONY

IMX326LQC-C

Marking

TBD

Notes on Handling

1. Static charge prevention

Image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- (1) Either handle bare handed or use non-chargeable gloves, clothes or material. Also use conductive shoes.
- (2) Use a wrist strap when handling directly.
- (3) Install grounded conductive mats on the floor and working table to prevent the generation of static electricity.
- (4) Ionized air is recommended for discharge when handling image sensors.
- (5) For the shipment of mounted boards, use boxes treated for the prevention of static charges.

2. Protection from dust and dirt

Image sensors are packed and delivered with care taken to protect the element glass surfaces from harmful dust and dirt. Clean glass surfaces with the following operations as required before use.

- (1) Perform all lens assembly and other work in a clean environment (class 1000 or less).
- (2) Do not touch the glass surface with hand and make any object contact with it. If dust or other is stuck to a glass surface, blow it off with an air blower. (For dust stuck through static electricity, ionized air is recommended.)
- (3) Clean with a cotton swab with ethyl alcohol if grease stained. Be careful not to scratch the glass.
- (4) Keep in a dedicated case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- (5) When a protective tape is applied before shipping, remove the tape applied for electrostatic protection just before use. Do not reuse the tape.

3. Installing (attaching)

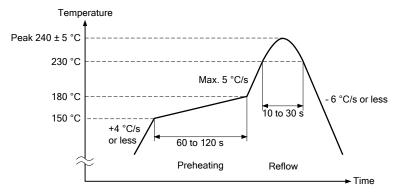
- (1) If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.
- (2) The adhesive may cause the marking on the rear surface to disappear.
- (3) If metal, etc., clash or rub against the package surface, the package may chip or fragment and generate dust.
- (4) Acrylate anaerobic adhesives are generally used to attach this product. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives to hold the product in place until the adhesive completely hardens. (Reference)
- (5) Note that the sensor may be damaged when using ultraviolet ray and infrared laser for mounting it.

4. Recommended reflow soldering conditions

The following items should be observed for reflow soldering.

(1) Temperature profile for reflow soldering

Control item	Profile (at part side surface)
1. Preheating	150 to 180 °C 60 to 120 s
2. Temperature up (down)	+4 °C/s or less (-6 °C/s or less)
3. Reflow temperature	Over 230 °C 10 to 30 s Max. 5 °C/s
4. Peak temperature	Max. 240 ± 5 °C



(2) Reflow conditions

- (a) Make sure the temperature of the upper surface of the seal glass resin adhesive portion of the package does not exceed 245 °C.
- (b) Perform the reflow soldering only one time.
- (c) Finish reflow soldering within 24 h after unsealing the degassed packing. Store the products under the condition of temperature of 30 °C or less and humidity of 70 % RH or less after unsealing the package.
- (d) Perform re-baking only one time under the condition at 125 $^{\circ}\text{C}$ for 24 h.

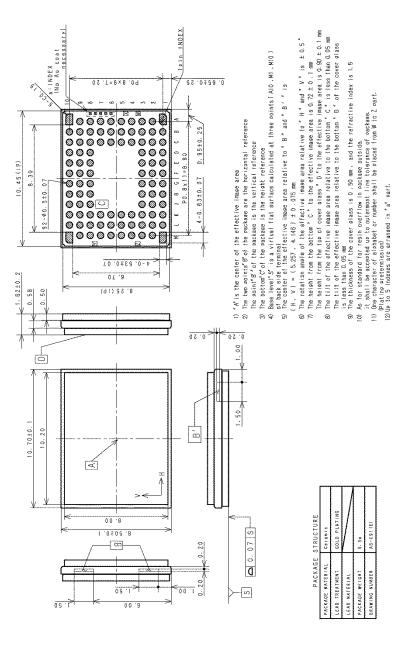
(3) Others

- (a) Carry out evaluation for the solder joint reliability in your company.
- (b) After the reflow, the paste residue of protective tape may remain around the seal glass. (The paste residue of protective tape should be ignored except remarkable one.)
- (c) Note that X-ray inspection may damage characteristics of the sensor.

5. Others

- (1) Do not expose to strong light (sun rays) for long periods, as the color filters of color devices will be discolored.
- (2) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or use in such conditions.
- (3) This product is precision optical parts, so care should be taken not to apply excessive mechanical shocks or force.
- (4) Note that imaging characteristics of the sensor may be affected when approaching strong electromagnetic wave or magnetic field during operation.
- (5) Note that image may be affected by the light leaked to optical black when using an infrared cut filter that has transparency in near infrared ray area during shooting subjects with high luminance.

Package Outline



92Pin LGA

List of Trademark Logos and Definition Statements



* Exmor R is a trademark of Sony Corporation. The Exmor R is a Sony's CMOS image sensor with significantly enhanced imaging characteristics including sensitivity and low noise by changing fundamental structure of ExmorTM pixel adopted column parallel A/D converter to back-illuminated type.

STARVIS

* STARVIS is a trademark of Sony Corporation. The STARVIS is back-illuminated pixel technology used in CMOS image sensors for surveillance camera applications. It features a sensitivity of 2000 mV or more per 1 µm² (color product, when imaging with a 706 cd/m² light source, F5.6 in 1 s accumulation equivalent), and realizes high picture quality in the visible-light and near infrared light regions.

Revision History

Date of change	Revision	Page	Contain of Change
30-May-16	0.1	-	First edition